



RADIO TEST REPORT

Test Report No. : 4786001507H-B

Applicant : **Panasonic Corporation of North America**
Type of Equipment : **Wireless Speaker System**
Model No. : **SC-NP10**
FCC ID : **ACJ-SC-NP10**
Test regulation : **FCC Part 15 Subpart C: 2012**
Test Result : **Complied**

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Date of test: January 29 and 30, 2013

Representative test engineer:

Takayuki S.

Takayuki Shimada
Engineer of WiSE Japan,
UL Verification Service

Approved by:

Takahiro Hatakeda
Leader of WiSE Japan,
UL Verification Service



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.
*As for the range of Accreditation in NVLAP, you may refer to the WEB address,
<http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap>

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13-EM-F0429

REVISION HISTORY

Original Test Report No.: 4786001507H-B

[illegible]**UL Japan, Inc.**

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SECTION 1: Customer information

Company Name	:	Panasonic Corporation *
Address	:	1006 Oaza Kadoma, Kadoma-shi, Osaka 571-8501 Japan
Telephone Number	:	+81-50-3687-9403
Facsimile Number	:	+81-6-6906-8800
Contact Person	:	Takeshi Tazawa

*Panasonic Corporation is on behalf of the applicant: Panasonic Corporation of North America.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	Wireless Speaker System
Model No.	:	SC-NP10
Serial No.	:	Refer to Section 4, Clause 4.2
Rating	:	AC120V/60Hz
Receipt Date of Sample	:	January 12, 2013
Country of Mass-production	:	Malaysia
Condition of EUT	:	Production prototype
		(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab

2.2 Product Description

General Specification

Clock frequency(ies) in the system	:	Main 4MHz
		DSP/DAMP 24.576MHz
		Bluetooth 16MHz

Radio Specification

[Bluetooth]

Radio Type	:	Transceiver
Frequency of Operation	:	2402-2480MHz
Modulation	:	FHSS
Power Supply (radio part input)	:	DC5.0V
Antenna type	:	PCB Pattern Antenna
Antenna Gain	:	-1.3dBi

[RFID]

Radio Type	:	Receiver
Receiving Frequency	:	13.56MHz
Antenna type	:	PCB Pattern Antenna

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : Test specification: FCC Part 15 Subpart C: 2012, final revised on December 27, 2012 and effective January 28, 2013

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928MHz,
2400-2483.5MHz, and 5725-5850MHz

*The EUT complies with FCC Part 15 Subpart B: 2012, final revised on December 27, 2012 and effective January 28, 2013.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst Margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.4	FCC: Section 15.207 IC: RSS-Gen 7.2.4	QP 19.1dB, 18.45127MHz, L AV 16.7dB, 18.45127MHz, L	Complied	-
Carrier Frequency Separation	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1) IC: RSS-210 A8.1 (b)	See data.	Complied	Conducted
20dB Bandwidth	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1) IC: RSS-210 A8.1 (a)		Complied	Conducted
Number of Hopping Frequency	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1)(iii) IC: RSS-210 A8.1 (d)		Complied	Conducted
Dwell time	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1)(iii) IC: RSS-210 A8.1 (d)		Complied	Conducted
Maximum Peak Output Power	FCC: FCC Public Notice DA 00-705 IC: RSS-Gen 4.8	FCC: Section15.247(a)(b)(1) IC: RSS-210 A8.4 (2)		Complied	Conducted
Spurious Emission & Band Edge Compliance	FCC: FCC Public Notice DA 00-705 IC: RSS-Gen 4.9	FCC: Section15.247(d) IC: RSS-210 A8.5 RSS-Gen 6 and 7.2.3	10.6dB 4804.000MHz, AV, Vertical	Complied	Conducted/ Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

* In case any questions arise about test procedure, ANSI C63.4: 2003 is also referred.

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FCC 15.31 (e)

This EUT provides stable voltage (DC5.0V) constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	N/A	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Conducted emission (+dB)
	150kHz-30MHz
No.1	3.5dB
No.2	3.6dB
No.3	3.6dB
No.4	3.6dB

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	4.3dB	5.0dB	5.1dB	4.9dB	5.8dB	4.4dB	4.3dB
No.2	4.3dB	5.2dB	5.1dB	5.0dB	5.7dB	4.3dB	4.2dB
No.3	4.6dB	5.0dB	5.1dB	5.0dB	5.7dB	4.5dB	4.2dB
No.4	4.8dB	5.2dB	5.0dB	5.0dB	5.7dB	5.2dB	4.2dB

*3m/1m/0.5m = Measurement distance

Power meter (+dB)	
Below 1GHz	Above 1GHz
1.0dB	1.0dB

Antenna terminal conducted emission and Power density (+dB)			Antenna terminal conducted emission (+dB)		Channel power (+dB)
Below 1GHz	1GHz-3GHz	3GHz-18GHz	18GHz-26.5GHz	26.5GHz-40GHz	
1.0dB	1.1dB	2.7dB	3.2dB	3.3dB	1.5dB

Conducted Emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test(3m)

The data listed in this test report has enough margin, more than the site margin.

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3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Data of EMI, Test instruments, and Test set up

Refer to APPENDIX.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

Bluetooth (BT): Transmitting (Tx), Payload: PRBS9
*Inquiry mode was not able to function on test tool.

Details of Operating Mode(s)

Test Item	Mode	Tested frequency
Conducted Emission, 20dB Bandwidth, Maximum Peak Output Power, Spurious Emission (Conducted/Radiated)	Tx (Hopping off) DH5, 3DH5	2402MHz 2441MHz 2480MHz
Carrier Frequency Separation	Tx (Hopping on) DH5, 3DH5	2402MHz 2441MHz 2480MHz
Number of Hopping Frequency	Tx (Hopping on) DH5, 3DH5	-
Dwell time	Tx (Hopping on), -DH1, DH3, DH5 -3DH1, 3DH3, 3DH5	-
Band Edge Compliance (Conducted)	Tx DH5, 3DH5 -Hopping on -Hopping off	2402MHz 2480MHz
99% Occupied Bandwidth	Tx DH5, 3DH5 -Hopping on -Hopping off	2402MHz 2441MHz 2480MHz
*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload length (except Dwell time test) *EUT has the power settings by the software as follows; Power settings: L12RNP10P69: BDR/EDR: 0x3e L12RNP10P51: BDR/EDR: 0x3c Software: ISRT Version 1.0.41.2996 *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.		

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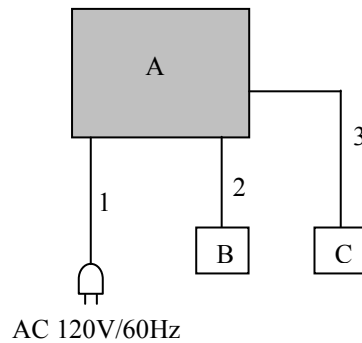
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4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remark
A	Wireless Speaker System	SC-NP10	L12RNP10P69 *1) L12RNP10P51 *2)	Panasonic Corporation	EUT
B	iPod shuffle	A1373	01	Apple Inc.	-
C	iPod shuffle	A1373	02	Apple Inc.	-

*1) Used for Radiated Spurious Emission

*2) Used for Antenna Terminal Conducted Tests

List of cables used

No.	Name	Length (m)	Shield		Remark
			Cable	Connector	
1	AC Cable	1.6	Unshielded	Unshielded	-
2	USB Cable	1.1	Shielded	Shielded	-
3	USB Cable	1.1	Shielded	Shielded	-

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SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber. The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector	: QP and AV
Measurement range	: 0.15-30MHz
Test data	: APPENDIX
Test result	: Pass

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SECTION 6: Radiated Spurious Emission

Test Procedure

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

The height of the measuring antenna varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Biconical	Logperiodic	Horn

In any 100kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20dBc was applied to the frequency over the limit of FCC 15.209 / Table 5 of RSS-Gen 7.2.5 (IC) and outside the restricted band of FCC15.205 / Table 3 of RSS-Gen 7.2.2 (IC).

Frequency	Below 1GHz	Above 1GHz		20dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV	PK
IF Bandwidth	BW 120kHz(T/R)	RBW: 1MHz VBW: 3MHz	RBW: 1MHz VBW: 10Hz *1)	RBW: 100kHz VBW: 300kHz (S/A)
Test Distance	3m	3m (below 10GHz), 1m *2) (above 10GHz)		3m (below 10GHz), 1m *2) (above 10GHz)

*1) Although 00-705 accepts VBW=10Hz for AV measurements, it was confirmed that superfluous smoothing was not performed.”

*2) Distance Factor: $20 \times \log(3.0\text{m}/1.0\text{m}) = 9.5\text{dB}$

The test was made on EUT at the normal use position.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 30M-25GHz

Test data : APPENDIX

Test result : Pass

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SECTION 7: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
20dB Bandwidth	3MHz	30kHz	100kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 to 3% of Span	Three times of RBW	Auto	Peak	Max Hold *1)	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak	-	Power Meter (Sensor: 50MHz BW)
Carrier Frequency Separation	3MHz	30kHz	100kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Number of Hopping Frequency	30MHz	300kHz	1MHz	Auto	Peak	Max Hold	Spectrum Analyzer
Dwell Time	Zero Span	100kHz, 1MHz	300kHz, 3MHz	As necessary capture the entire dwell time per hopping channel	Peak	Max Hold	Spectrum Analyzer
Conducted Spurious Emission *2)	9kHz to 150kHz	200Hz	620Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150kHz to 30MHz	9.1kHz	27kHz				
	30MHz to 25GHz (Less or equal to 5GHz)	100kHz	300kHz				
Conducted Spurious Emission Band Edge compliance	10MHz	100kHz	300kHz	Auto	Peak	Max Hold	Spectrum Analyzer

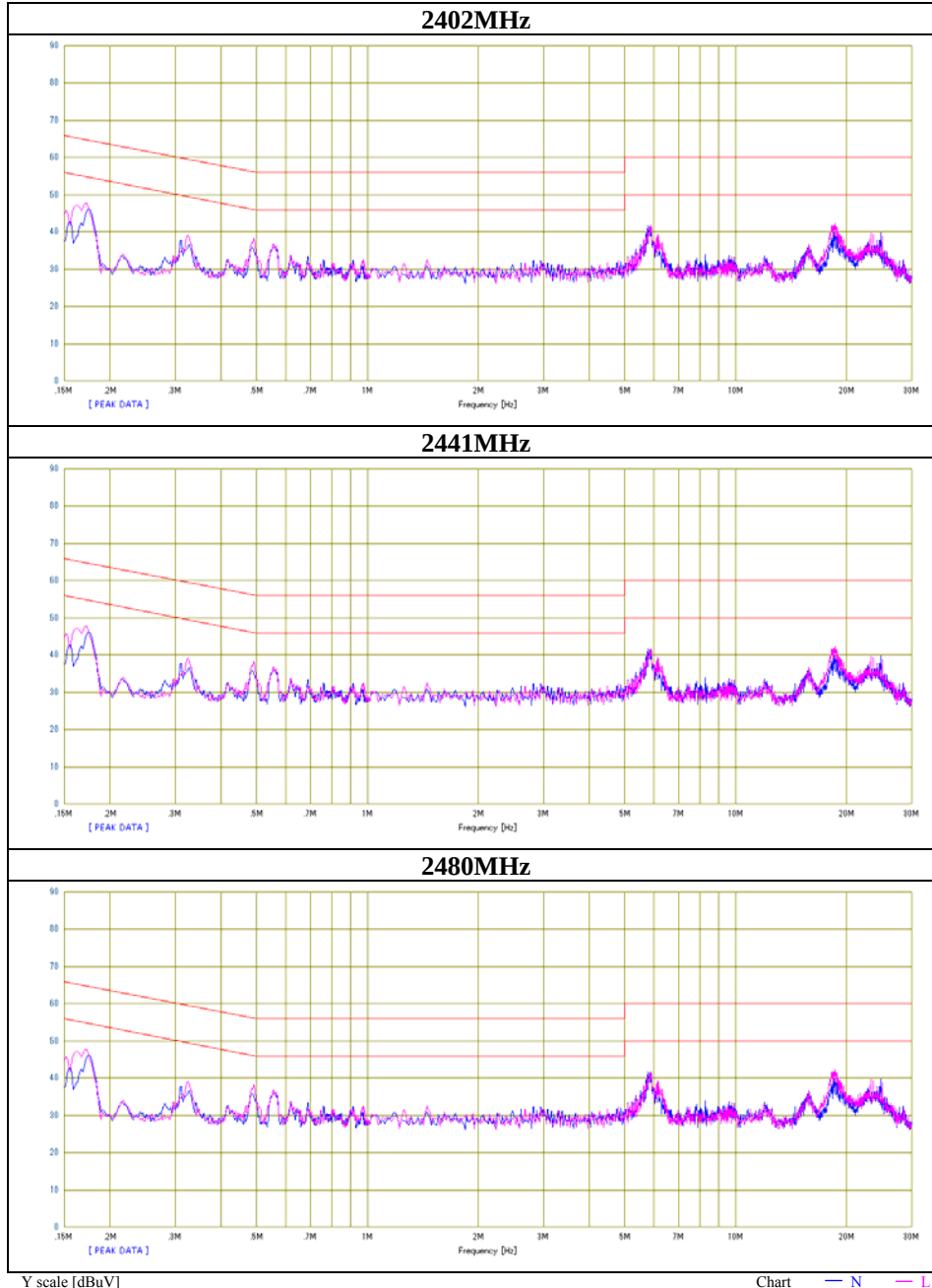
*1) The measurement was performed with Max Hold since the duty cycle was not 100%.
*2) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents. Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart. (9kHz-150kHz:RBW=200Hz, 150kHz-30MHz:RBW=9.1kHz)

The test results and limit are rounded off to two decimals place, so some differences might be observed.

Test data : APPENDIX
Test result : Pass

Conducted Emission

Test place	Head Office EMC Lab. No.2 Semi Anechoic Chamber
Report No.	4786001507H
Date	01/30/2013
Temperature/ Humidity	19 deg. C / 34% RH
Engineer	Keisuke Kawamura
Mode	Tx DH5



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Conducted Emission

DATA OF CONDUCTED EMISSION TEST

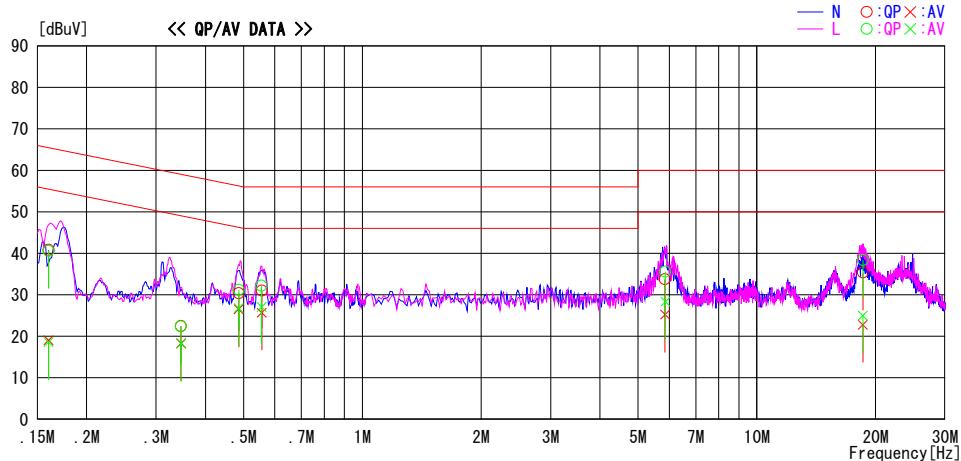
UL Japan, Inc. Head Office EMC Lab. No.2 Semi Anechoic Chamber
Date : 2013/01/30

Report No. : 4786001507H

Temp./Humi. : 19deg. C / 34% RH
Engineer : Keisuke Kawamura

Mode / Remarks : 3DH5 2441MHz

LIMIT : FCC15.207 QP
FCC15.207 AV



Frequency [MHz]	Reading Level		Corr. Factor	Results		Limit		Margin		Phase	Comment
	QP [dBuV]	AV [dBuV]		QP [dBuV]	AV [dBuV]	QP [dBuV]	AV [dBuV]	QP [dB]	AV [dB]		
0.16011	27.6	5.9	13.2	40.8	19.1	65.5	55.5	24.7	36.4	N	
0.34705	9.3	5.1	13.2	22.5	18.3	59.0	49.0	36.5	30.7	N	
0.48605	17.2	13.3	13.2	30.4	26.5	56.2	46.2	25.8	19.7	N	
0.55611	17.8	12.5	13.2	31.0	25.7	56.0	46.0	25.0	20.3	N	
5.85004	19.7	11.2	14.0	33.7	25.2	60.0	50.0	26.3	24.8	N	
18.57152	20.4	7.8	15.0	35.4	22.8	60.0	50.0	24.6	27.2	N	
0.16011	27.4	5.4	13.2	40.6	18.6	65.5	55.5	24.9	36.9	L	
0.34691	9.2	5.0	13.2	22.4	18.2	59.0	49.0	36.6	30.8	L	
0.48585	18.0	13.6	13.2	31.2	26.8	56.2	46.2	25.0	19.4	L	
0.55521	19.0	13.9	13.2	32.2	27.1	56.0	46.0	23.8	18.9	L	
5.86053	21.6	14.3	14.0	35.6	28.3	60.0	50.0	24.4	21.7	L	
18.57152	23.4	10.0	15.0	38.4	25.0	60.0	50.0	21.6	25.0	L	

CHART:WITH FACTOR,Peak hold data. CALCULATION:RESULT=READING+C.F(LISN LOSS + ATTEN LOSS + CABLE LOSS)
Except for the above table : adequate margin data below the limits.

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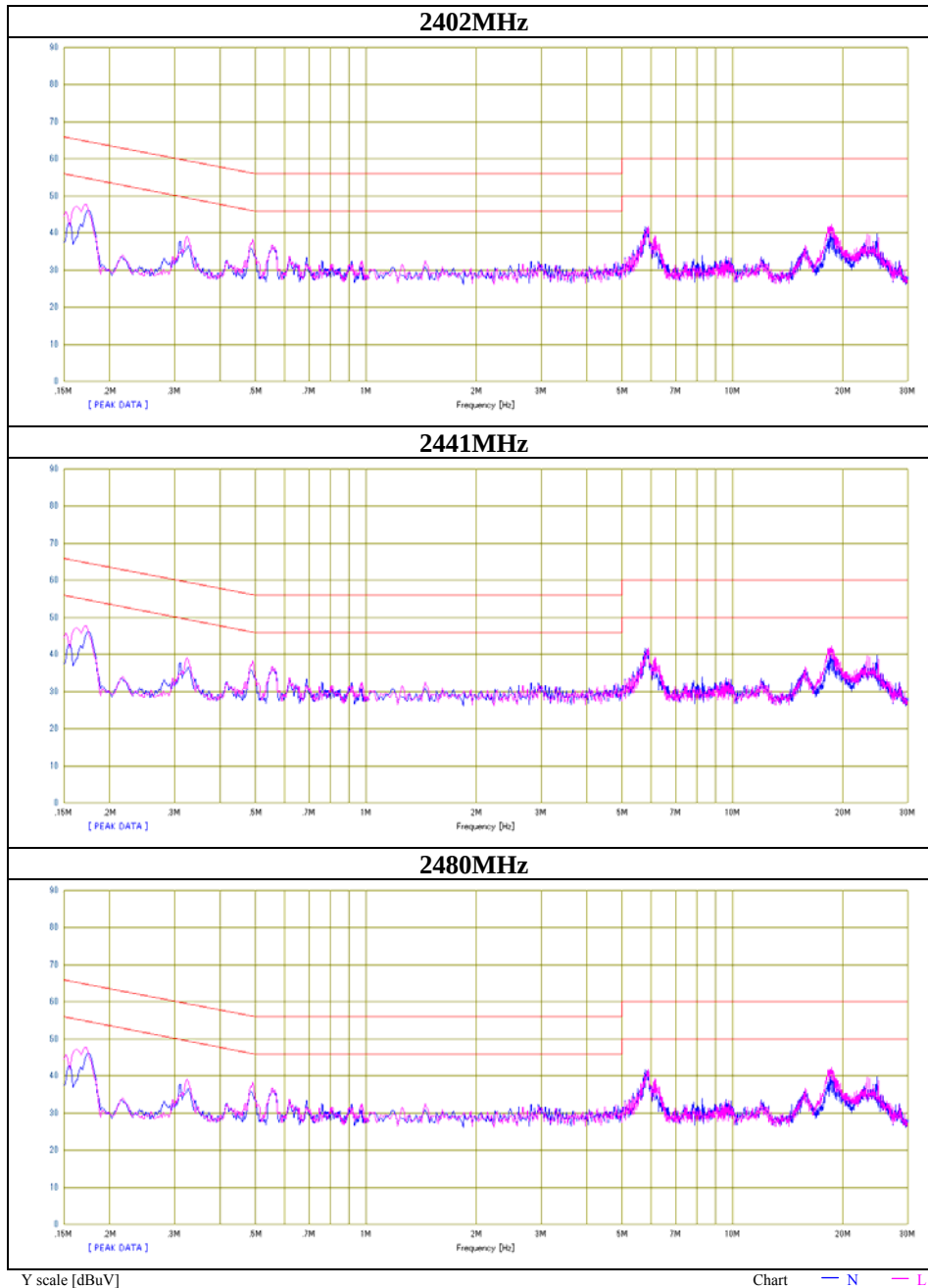
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Conducted Emission

Test place	Head Office EMC Lab. No.2 Semi Anechoic Chamber
Report No.	4786001507H
Date	01/30/2013
Temperature/ Humidity	19 deg. C / 34% RH
Engineer	Keisuke Kawamura
Mode	Tx 3DH5



20dB Bandwidth and Carrier Frequency Separation

Test place Head Office EMC Lab. No.3 Measurement Room
Report No. 4786001507H
Date 01/29/2013
Temperature/ Humidity 23 deg. C / 35% RH
Engineer Takayuki Shimada
Mode Tx (Hopping off/on) DH5/3DH5

Mode	Freq. [MHz]	20dB Bandwidth [MHz]	Carrier Frequency Separation [MHz]	Limit for Carrier Frequency separation [MHz]
DH5	2402.0	1.000	1.000	≥ 0.667
DH5	2441.0	1.013	1.000	≥ 0.675
DH5	2480.0	0.947	1.000	≥ 0.631
3DH5	2402.0	1.279	1.000	≥ 0.853
3DH5	2441.0	1.278	1.000	≥ 0.852
3DH5	2480.0	1.278	1.000	≥ 0.852

Limit: Two-thirds of 20dB Bandwidth or 25kHz (whichever is greater).

No limit applies to 20dB Bandwidth.

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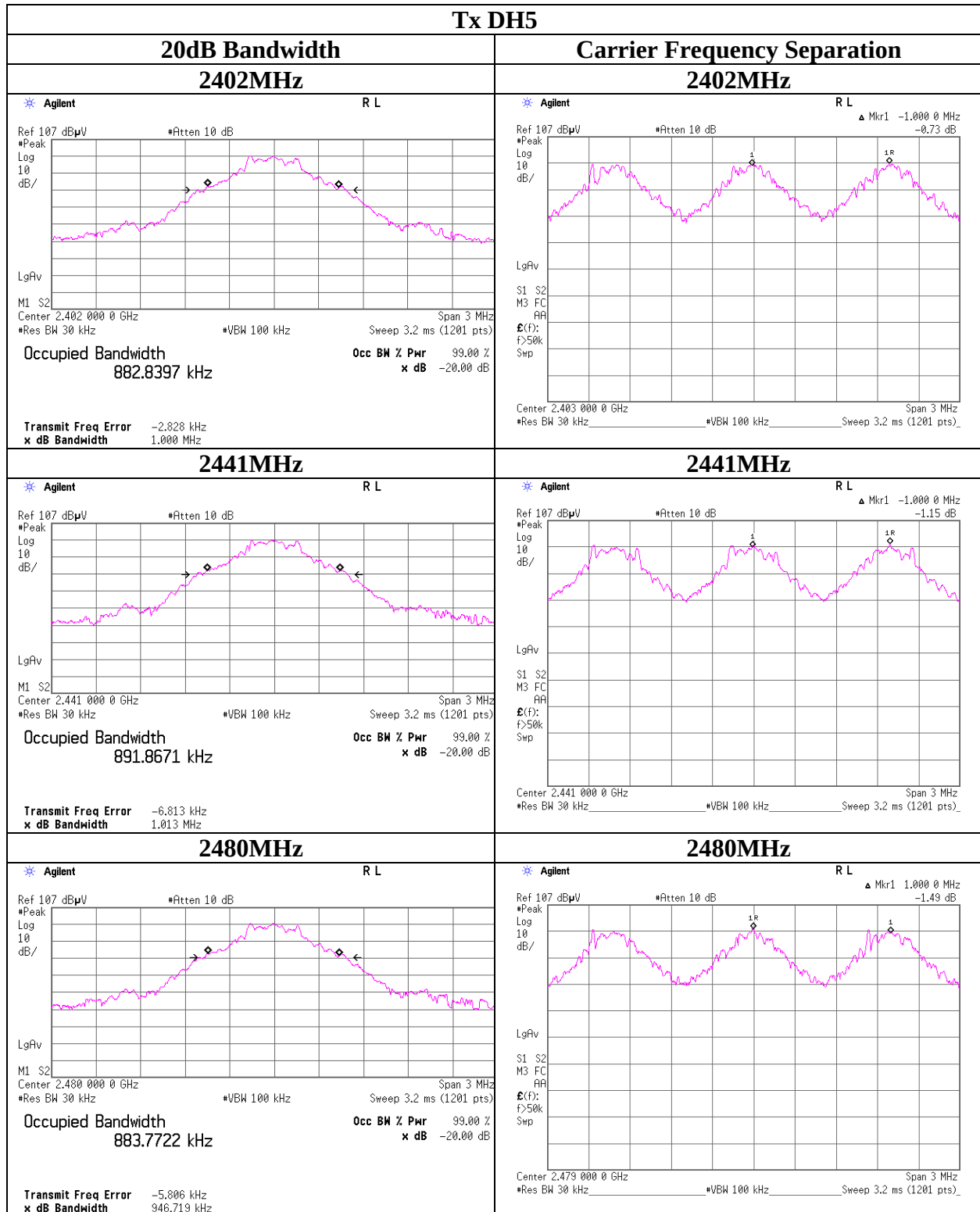
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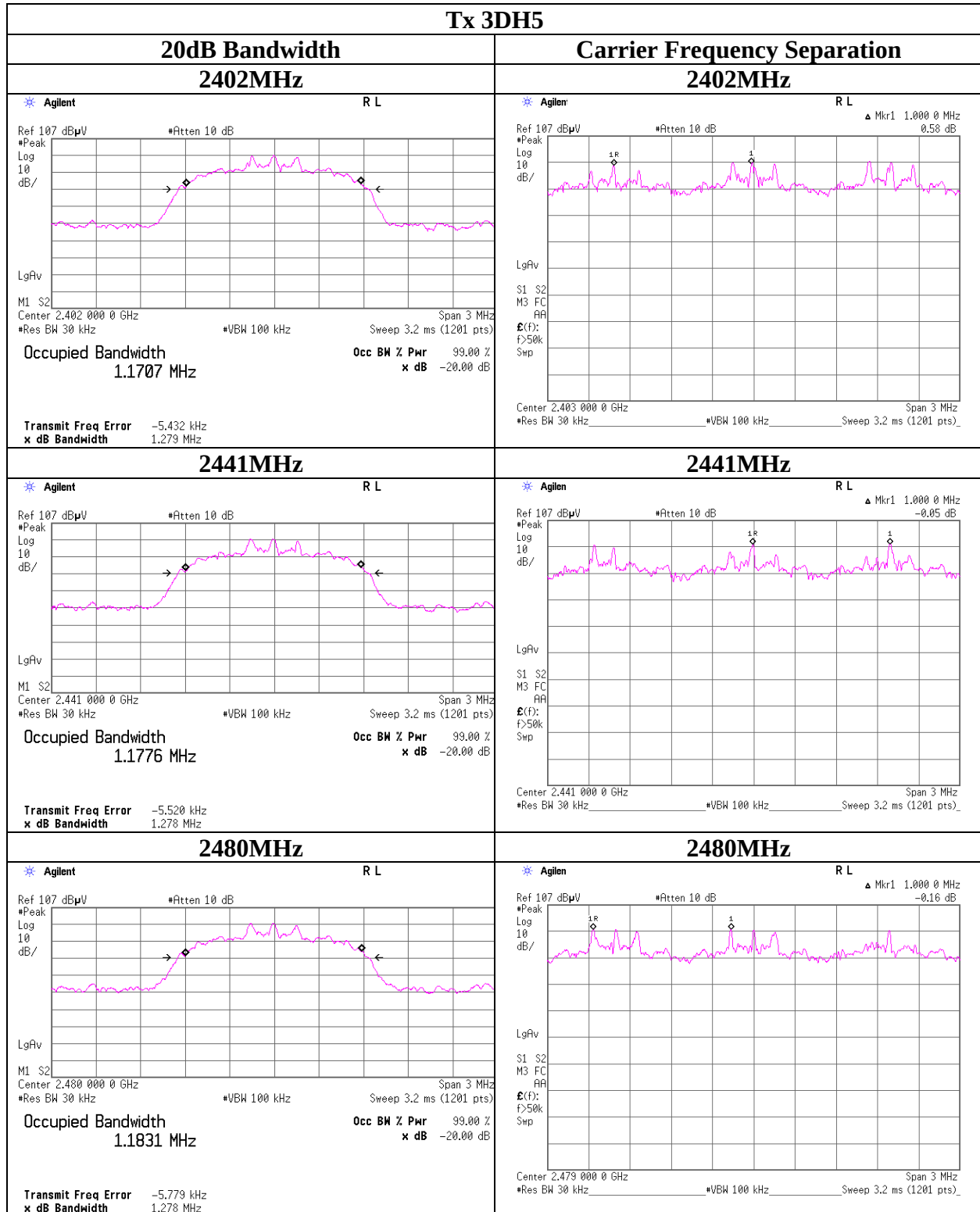
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20dB Bandwidth and Carrier Frequency Separation



20dB Bandwidth and Carrier Frequency Separation



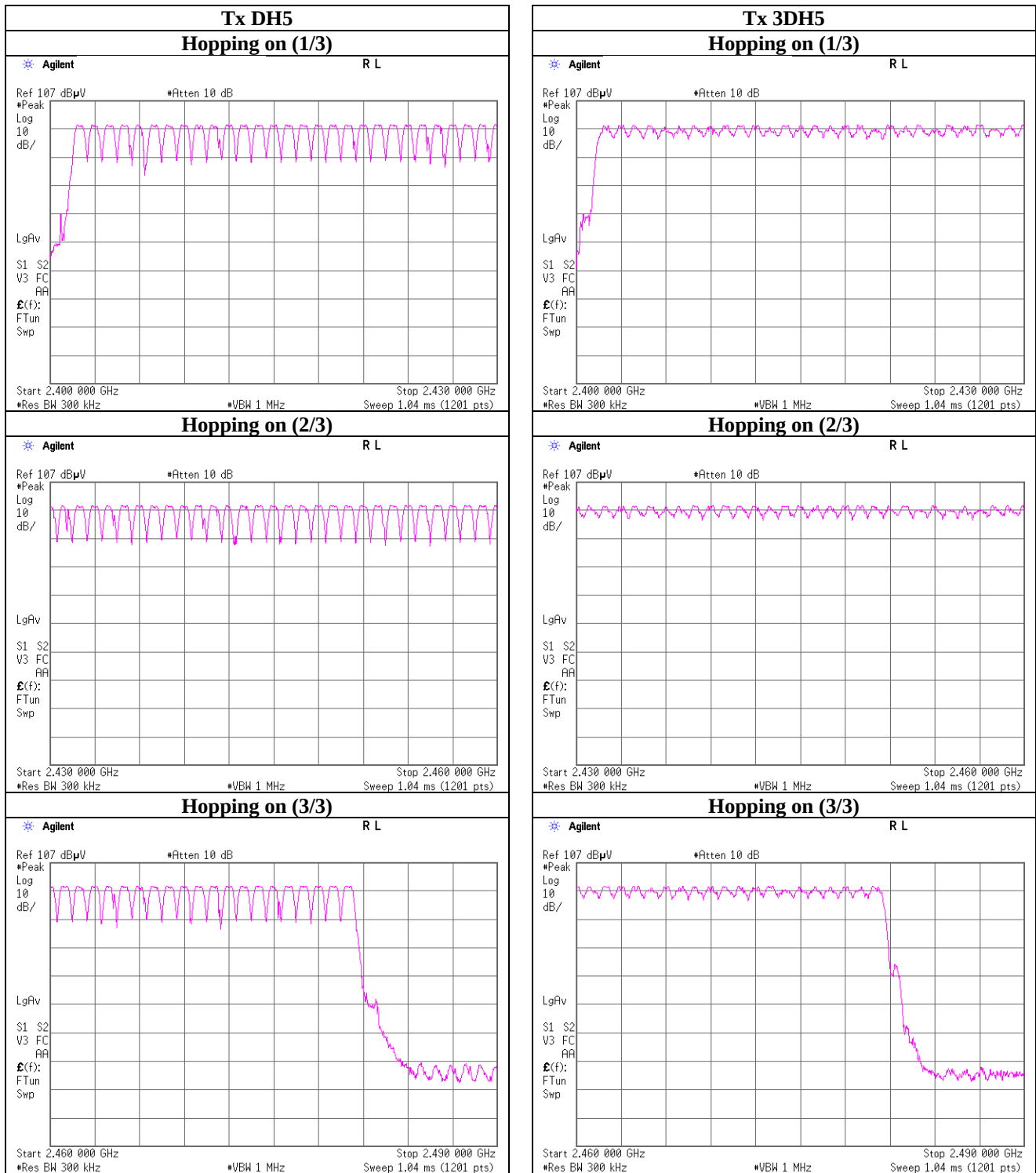
Number of Hopping Frequency

Test place Head Office EMC Lab. No.3 Measurement Room
Report No. 4786001507H
Date 01/29/2013
Temperature/ Humidity 23 deg. C / 35% RH
Engineer Takayuki Shimada
Mode Tx (Hopping on) DH5/3DH5

Mode	Number of channel [times]	Limit [times]
DH5	79	≥ 15
3DH5	79	≥ 15

Test was not performed at AFH mode whose number of hopping channel is 20 channels because this Bluetooth radio is in compliance of Bluetooth Specification.

Number of Hopping Frequency



Dwell time

Test place	Head Office EMC Lab. No.3 Measurement Room
Report No.	4786001507H
Date	01/29/2013
Temperature/ Humidity	23 deg. C / 35% RH
Engineer	Takayuki Shimada
Mode	Tx (Hopping on) DH5/3DH5

Mode	Number of transmission in a 31.6(79 Hopping x 0.4) / 12.8(32 Hopping x 0.4)second period					Length of transmission time [msec]	Result [msec]	Limit [msec]
DH1	52.2 times	/	5 sec.	x	31.6 sec. = 330 times	0.409	135	400
DH3	28.6 times	/	5 sec.	x	31.6 sec. = 181 times	1.670	302	400
DH5	18.2 times	/	5 sec.	x	31.6 sec. = 116 times	2.927	340	400
3DH1	51.6 times	/	5 sec.	x	31.6 sec. = 327 times	0.421	138	400
3DH3	31.4 times	/	5 sec.	x	31.6 sec. = 199 times	1.674	333	400
3DH5	18.4 times	/	5 sec.	x	31.6 sec. = 117 times	2.927	342	400

Sample Calculation

Result = Number of transmission x Length of transmittion time

*Average data of 5 tests.(except Inquiry)

Mode	Sampling [times]					Average [times]
	1	2	3	4	5	
DH1	52	53	52	51	53	52.2
DH3	39	25	27	25	27	28.6
DH5	15	20	20	23	13	18.2
3DH1	52	51	51	50	54	51.6
3DH3	32	29	30	35	31	31.4
3DH5	22	17	15	19	19	18.4

Sample Calculation

Average= Summation(Sampling 1 to 5) / 5

This device complies with the Bluetooth protocol for FHSS operation, employing a pseudo random channel selection and hopping rate to ensure that the occupancy time in $N \times 0.4s$, where N is the number of channels being used in the hopping sequence ($20 \leq N \leq 79$), is always less than $0.4s$ regardless of packet size. This is confirmed in the test report for $N=79$.

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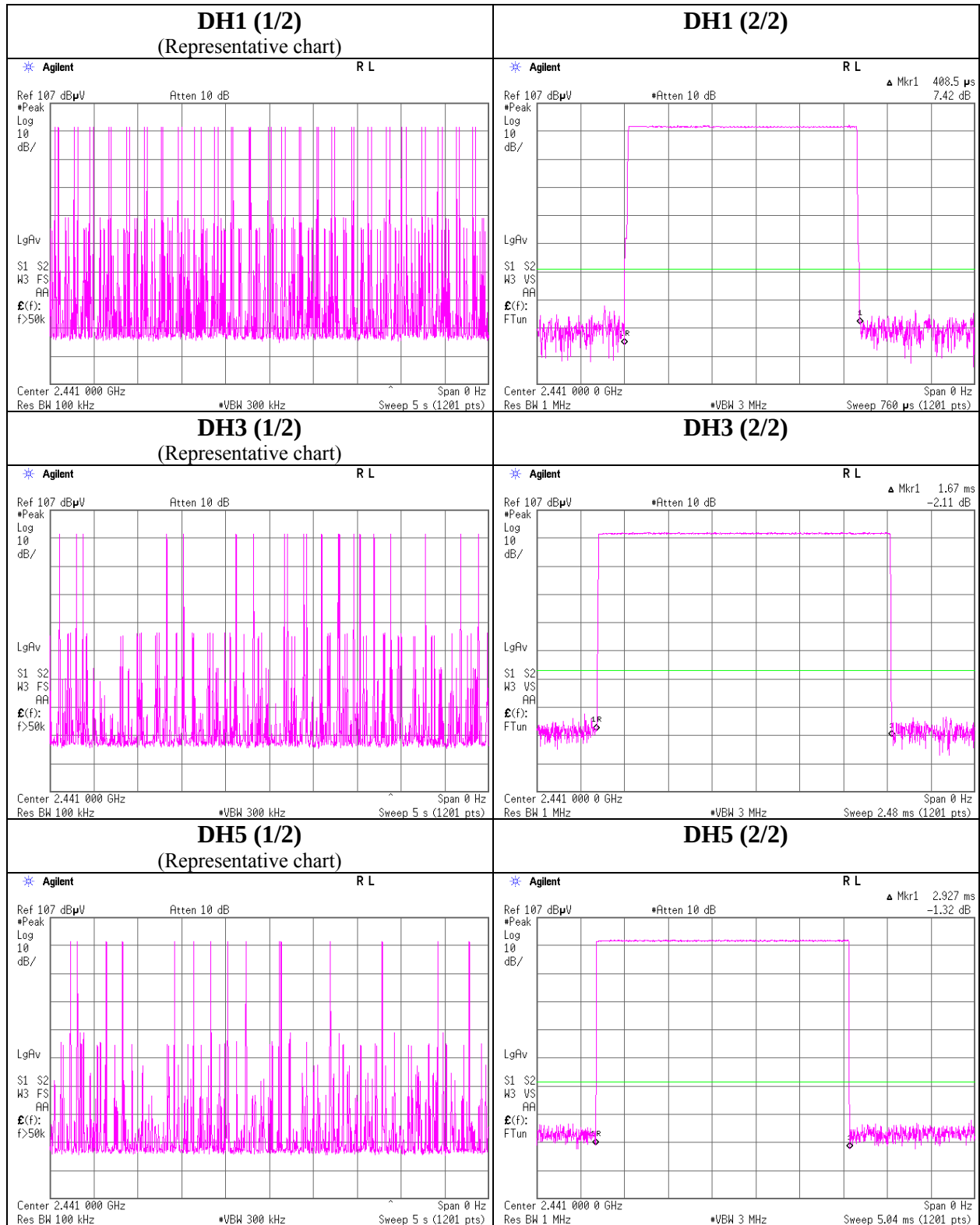
Head Office EMC Lab.

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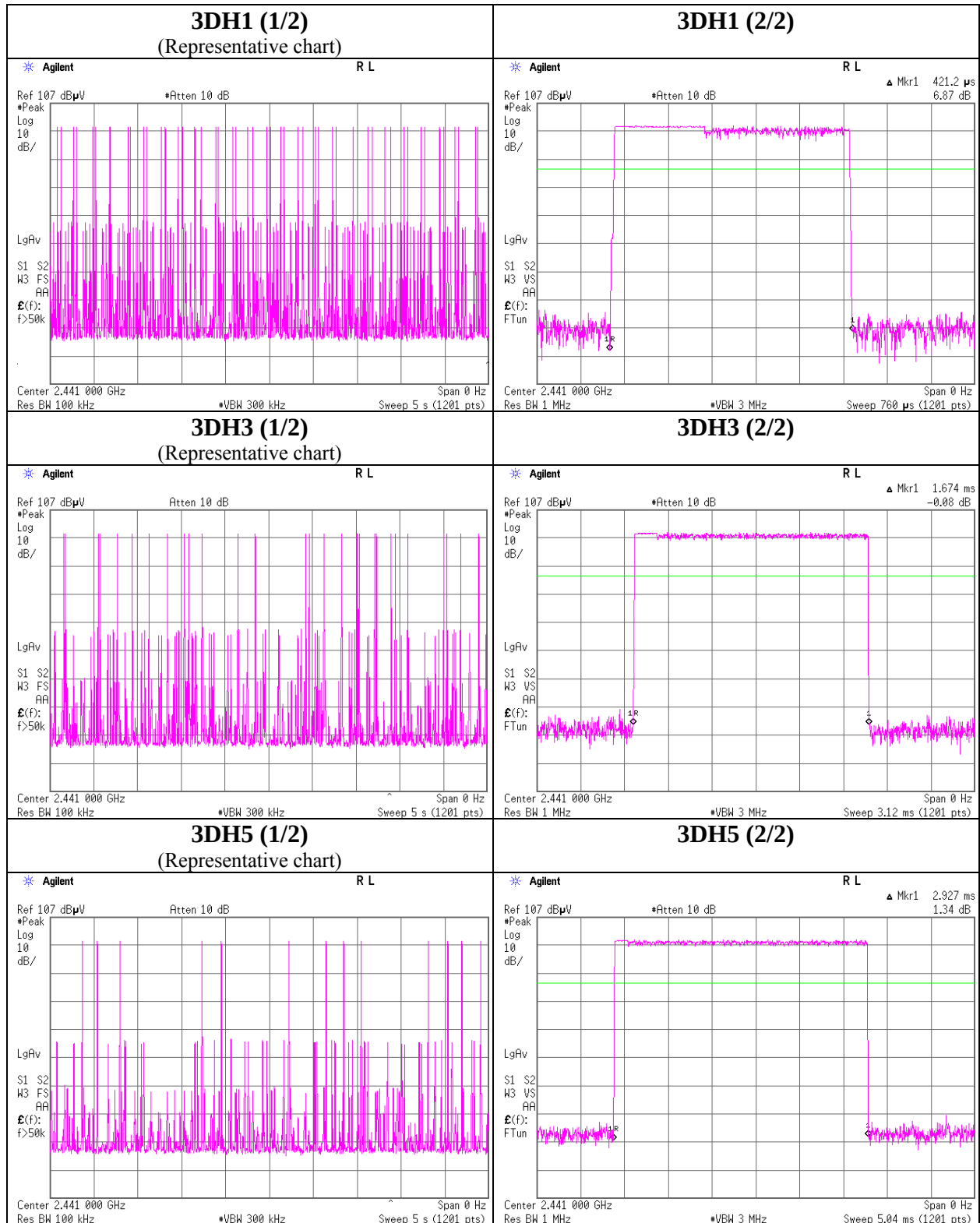
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Dwell time



Dwell time



Maximum Peak Output Power

Test place Head Office EMC Lab. No.3 Measurement Room
Report No. 4786001507H
Date 01/29/2013
Temperature/ Humidity 23 deg. C / 35% RH
Engineer Takayuki Shimada
Mode Tx (Hopping off) DH5/3DH5

Mode	Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
DH5	2402.0	-8.21	2.22	10.00	4.01	2.52	20.96	125	16.95
DH5	2441.0	-7.88	2.23	10.00	4.35	2.72	20.96	125	16.61
DH5	2480.0	-7.96	2.24	10.00	4.28	2.68	20.96	125	16.68
3DH5	2402.0	-8.04	2.22	10.00	4.18	2.62	20.96	125	16.78
3DH5	2441.0	-7.80	2.23	10.00	4.43	2.77	20.96	125	16.53
3DH5	2480.0	-7.85	2.24	10.00	4.39	2.75	20.96	125	16.57

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied)+ Attenuator

Test was not performed at AFH mode, because the decrease of number of channel (min: 20ch) at AFH mode does not influence on the output power and bandwidth of the EUT. As this device had AFH mode and frequency separation could not meet the requirement of over 20dB BW without 2/3 relaxation, 125mW power limit was applied to it.

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Radiated Spurious Emission

Test place Head Office EMC Lab. No.3 Semi Anechoic Chamber
Report No. 4786001507H
Date 01/29/2013 01/29/2013
Temperature/ Humidity 22 deg. C / 30% RH 22 deg. C / 30% RH
Engineer Hiroshi Kukita Katsunori Okai
(1-10GHz) (Below 1GHz and Above 10GHz)
Mode Tx, DH5 2402MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	73.727	QP	43.5	6.5	7.8	32.1	25.7	40.0	14.3	
Hori	175.999	QP	34.6	15.9	8.9	32.2	27.2	43.5	16.3	
Hori	307.198	QP	41.1	14.8	10.0	32.1	33.8	46.0	12.2	
Hori	417.789	QP	34.4	17.5	10.8	32.0	30.7	46.0	15.3	
Hori	761.845	QP	32.8	21.3	12.9	31.7	35.3	46.0	10.7	
Hori	958.456	QP	28.0	22.8	13.8	30.7	33.9	46.0	12.1	
Hori	2390.000	PK	46.3	27.4	2.3	32.4	43.6	73.9	30.3	
Hori	4804.000	PK	45.0	31.6	4.1	31.4	49.3	73.9	24.6	
Hori	7206.000	PK	41.8	36.3	4.7	32.4	50.4	73.9	23.5	
Hori	9608.000	PK	41.8	38.1	5.4	33.0	52.3	73.9	21.6	
Hori	2390.000	AV	30.0	27.4	2.3	32.4	27.3	53.9	26.6	
Hori	4804.000	AV	37.7	31.6	4.1	31.4	42.0	53.9	11.9	
Hori	7206.000	AV	29.7	36.3	4.7	32.4	38.3	53.9	15.6	
Hori	9608.000	AV	29.9	38.1	5.4	33.0	40.4	53.9	13.5	
Vert	32.366	QP	28.2	17.1	7.1	32.2	20.2	40.0	19.8	
Vert	98.303	QP	41.4	9.8	8.1	32.3	27.0	43.5	16.5	
Vert	223.999	QP	34.3	17.0	9.4	32.2	28.5	46.0	17.5	
Vert	307.197	QP	31.0	14.8	10.0	32.1	23.7	46.0	22.3	
Vert	761.847	QP	30.3	21.3	12.9	31.7	32.8	46.0	13.2	
Vert	958.454	QP	25.8	22.8	13.8	30.7	31.7	46.0	14.3	
Vert	2390.000	PK	43.0	27.4	2.3	32.4	40.3	73.9	33.6	
Vert	4804.000	PK	45.7	31.6	4.1	31.4	50.0	73.9	23.9	
Vert	7206.000	PK	41.2	36.3	4.7	32.4	49.8	73.9	24.1	
Vert	9608.000	PK	41.8	38.1	5.4	33.0	52.3	73.9	21.6	
Vert	2390.000	AV	29.5	27.4	2.3	32.4	26.8	53.9	27.1	
Vert	4804.000	AV	39.0	31.6	4.1	31.4	43.3	53.9	10.6	
Vert	7206.000	AV	29.8	36.3	4.7	32.4	38.4	53.9	15.5	
Vert	9608.000	AV	29.9	38.1	5.4	33.0	40.4	53.9	13.5	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 10GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Distance factor: 10GHz-26.5GHz 20log(3.0m/1.0m)= 9.5dB

20dBc Data Sheet

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	2402.000	PK	98.3	27.4	2.3	32.4	95.6	-	-	Carrier
Hori	2400.000	PK	54.2	27.4	2.3	32.4	51.5	75.6	24.1	
Vert	2402.000	PK	95.0	27.4	2.3	32.4	92.3	-	-	Carrier
Vert	2400.000	PK	54.0	27.4	2.3	32.4	51.3	72.3	21.0	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 10GHz)) - Gain(Amplifier)

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Radiated Spurious Emission

Test place	Head Office EMC Lab. No.3 Semi Anechoic Chamber	
Report No.	4786001507H	
Date	01/29/2013	01/29/2013
Temperature/ Humidity	22 deg. C / 30% RH	22 deg. C / 30% RH
Engineer	Hiroshi Kukita (1-10GHz)	Katsunori Okai (Below 1GHz and Above 10GHz)
Mode	Tx, DH5 2441MHz	

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	73.727	QP	43.5	6.5	7.8	32.1	25.7	40.0	14.3	
Hori	176.002	QP	34.4	15.9	8.9	32.2	27.0	43.5	16.5	
Hori	307.197	QP	40.3	14.8	10.0	32.1	33.0	46.0	13.0	
Hori	417.788	QP	34.5	17.5	10.8	32.0	30.8	46.0	15.2	
Hori	761.849	QP	32.5	21.3	12.9	31.7	35.0	46.0	11.0	
Hori	958.456	QP	27.9	22.8	13.8	30.7	33.8	46.0	12.2	
Hori	4882.000	PK	43.0	31.9	4.0	31.4	47.5	73.9	26.4	
Hori	7323.000	PK	41.2	36.5	4.7	32.5	49.9	73.9	24.0	
Hori	9764.000	PK	41.2	38.3	5.4	33.0	51.9	73.9	22.0	
Hori	4882.000	AV	36.0	31.9	4.0	31.4	40.5	53.9	13.4	
Hori	7323.000	AV	32.1	36.5	4.7	32.5	40.8	53.9	13.1	
Hori	9764.000	AV	32.0	38.3	5.4	33.0	42.7	53.9	11.2	
Vert	32.188	QP	28.2	17.2	7.1	32.2	20.3	40.0	19.7	
Vert	98.303	QP	41.5	9.8	8.1	32.3	27.1	43.5	16.4	
Vert	223.999	QP	34.3	17.0	9.4	32.2	28.5	46.0	17.5	
Vert	565.243	QP	29.5	18.9	11.8	32.0	28.2	46.0	17.8	
Vert	761.849	QP	30.9	21.3	12.9	31.7	33.4	46.0	12.6	
Vert	958.455	QP	26.2	22.8	13.8	30.7	32.1	46.0	13.9	
Vert	4882.000	PK	44.2	31.9	4.0	31.4	48.7	73.9	25.2	
Vert	7323.000	PK	41.2	36.5	4.7	32.5	49.9	73.9	24.0	
Vert	9764.000	PK	41.2	38.3	5.4	33.0	51.9	73.9	22.0	
Vert	4882.000	AV	38.0	31.9	4.0	31.4	42.5	53.9	11.4	
Vert	7323.000	AV	31.9	36.5	4.7	32.5	40.6	53.9	13.3	
Vert	9764.000	AV	32.0	38.3	5.4	33.0	42.7	53.9	11.2	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 10GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Distance factor: 10GHz-26.5GHz 20log(3.0m/1.0m)= 9.5dB

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Radiated Spurious Emission

Test place Head Office EMC Lab. No.3 Semi Anechoic Chamber
Report No. 4786001507H
Date 01/29/2013 01/29/2013
Temperature/ Humidity 22 deg. C / 30% RH 22 deg. C / 30% RH
Engineer Hiroshi Kukita Katsunori Okai
(1-10GHz) (Below 1GHz and Above 10GHz)
Mode Tx, DH5 2480MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	73.726	QP	43.9	6.5	7.8	32.1	26.1	40.0	13.9	
Hori	184.318	QP	37.6	16.2	9.0	32.2	30.6	43.5	12.9	
Hori	307.198	QP	40.4	14.8	10.0	32.1	33.1	46.0	12.9	
Hori	417.788	QP	34.4	17.5	10.8	32.0	30.7	46.0	15.3	
Hori	761.849	QP	32.5	21.3	12.9	31.7	35.0	46.0	11.0	
Hori	958.456	QP	27.7	22.8	13.8	30.7	33.6	46.0	12.4	
Hori	2483.500	PK	53.7	27.7	2.3	32.3	51.4	73.9	22.5	
Hori	4960.000	PK	45.6	32.2	4.0	31.4	50.4	73.9	23.5	
Hori	7440.000	PK	42.2	36.7	4.7	32.6	51.0	73.9	22.9	
Hori	9920.000	PK	42.3	38.6	5.4	33.1	53.2	73.9	20.7	
Hori	2483.500	AV	37.0	27.7	2.3	32.3	34.7	53.9	19.2	
Hori	4960.000	AV	37.7	32.2	4.0	31.4	42.5	53.9	11.4	
Hori	7440.000	AV	31.8	36.7	4.7	32.6	40.6	53.9	13.3	
Hori	9920.000	AV	31.9	38.6	5.4	33.1	42.8	53.9	11.1	
Vert	73.727	QP	43.7	6.5	7.8	32.1	25.9	40.0	14.1	
Vert	98.303	QP	41.4	9.8	8.1	32.3	27.0	43.5	16.5	
Vert	183.999	QP	35.4	16.2	9.0	32.2	28.4	43.5	15.1	
Vert	565.242	QP	30.3	18.9	11.8	32.0	29.0	46.0	17.0	
Vert	761.849	QP	30.6	21.3	12.9	31.7	33.1	46.0	12.9	
Vert	958.455	QP	26.2	22.8	13.8	30.7	32.1	46.0	13.9	
Vert	2483.500	PK	47.5	27.7	2.3	32.3	45.2	73.9	28.7	
Vert	4960.000	PK	46.4	32.2	4.0	31.4	51.2	73.9	22.7	
Vert	7440.000	PK	42.3	36.7	4.7	32.6	51.1	73.9	22.8	
Vert	9920.000	PK	41.9	38.6	5.4	33.1	52.8	73.9	21.1	
Vert	2483.500	AV	34.4	27.7	2.3	32.3	32.1	53.9	21.8	
Vert	4960.000	AV	38.3	32.2	4.0	31.4	43.1	53.9	10.8	
Vert	7440.000	AV	31.9	36.7	4.7	32.6	40.7	53.9	13.2	
Vert	9920.000	AV	32.0	38.6	5.4	33.1	42.9	53.9	11.0	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 10GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Distance factor: 10GHz-26.5GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Spurious Emission

Test place : Head Office EMC Lab. No.3 Semi Anechoic Chamber
Report No. : 4786001507H
Date : 01/29/2013
Temperature/ Humidity : 22 deg. C / 30% RH
Engineer : Hiroshi Kukita
Mode : Tx, 3DH5 2402MHz
Katsunori Okai
(Below 1GHz and Above 10GHz)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	73.727	QP	43.3	6.5	7.8	32.1	25.5	40.0	14.5	
Hori	184.318	QP	37.3	16.2	9.0	32.2	30.3	43.5	13.2	
Hori	307.198	QP	40.4	14.8	10.0	32.1	33.1	46.0	12.9	
Hori	417.788	QP	34.5	17.5	10.8	32.0	30.8	46.0	15.2	
Hori	761.849	QP	32.0	21.3	12.9	31.7	34.5	46.0	11.5	
Hori	958.455	QP	27.8	22.8	13.8	30.7	33.7	46.0	12.3	
Hori	2390.000	PK	46.0	27.4	2.3	32.4	43.3	73.9	30.6	
Hori	4804.000	PK	44.6	31.6	4.1	31.4	48.9	73.9	25.0	
Hori	7206.000	PK	42.3	36.3	4.7	32.4	50.9	73.9	23.0	
Hori	9608.000	PK	41.5	38.1	5.4	33.0	52.0	73.9	21.9	
Hori	2390.000	AV	31.2	27.4	2.3	32.4	28.5	53.9	25.4	
Hori	4804.000	AV	35.0	31.6	4.1	31.4	39.3	53.9	14.6	
Hori	7206.000	AV	31.4	36.3	4.7	32.4	40.0	53.9	13.9	
Hori	9608.000	AV	31.4	38.1	5.4	33.0	41.9	53.9	12.0	
Vert	73.727	QP	41.6	6.5	7.8	32.1	23.8	40.0	16.2	
Vert	98.303	QP	41.2	9.8	8.1	32.3	26.8	43.5	16.7	
Vert	183.999	QP	35.1	16.2	9.0	32.2	28.1	43.5	15.4	
Vert	223.999	QP	36.6	17.0	9.4	32.2	30.8	46.0	15.2	
Vert	737.273	QP	29.7	20.9	12.7	31.8	31.5	46.0	14.5	
Vert	761.849	QP	30.6	21.3	12.9	31.7	33.1	46.0	12.9	
Vert	958.456	QP	26.1	22.8	13.8	30.7	32.0	46.0	14.0	
Vert	2390.000	PK	46.0	27.4	2.3	32.4	43.3	73.9	30.6	
Vert	4804.000	PK	45.1	31.6	4.1	31.4	49.4	73.9	24.5	
Vert	7206.000	PK	41.5	36.3	4.7	32.4	50.1	73.9	23.8	
Vert	9608.000	PK	42.3	38.1	5.4	33.0	52.8	73.9	21.1	
Vert	2390.000	AV	32.0	27.4	2.3	32.4	29.3	53.9	24.6	
Vert	4804.000	AV	35.0	31.6	4.1	31.4	39.3	53.9	14.6	
Vert	7206.000	AV	31.9	36.3	4.7	32.4	40.5	53.9	13.4	
Vert	9608.000	AV	31.4	38.1	5.4	33.0	41.9	53.9	12.0	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 10GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Distance factor: 10GHz-26.5GHz 20log(3.0m/1.0m)= 9.5dB

20dBc Data Sheet

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	2402.000	PK	96.0	27.4	2.3	32.4	93.3	-	-	Carrier
Hori	2400.000	PK	44.2	27.4	2.3	32.4	41.5	73.3	31.8	
Vert	2402.000	PK	95.5	27.4	2.3	32.4	92.8	-	-	Carrier
Vert	2400.000	PK	48.0	27.4	2.3	32.4	45.3	72.8	27.5	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 10GHz)) - Gain(Amplifier)

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Radiated Spurious Emission

Test place Head Office EMC Lab. No.3 Semi Anechoic Chamber
Report No. 4786001507H
Date 01/29/2013 01/29/2013
Temperature/ Humidity 22 deg. C / 30% RH 22 deg. C / 30% RH
Engineer Hiroshi Kukita Katsunori Okai
(1-10GHz) (Below 1GHz and Above 10GHz)
Mode Tx, 3DH5 2441MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	73.727	QP	43.1	6.5	7.8	32.1	25.3	40.0	14.7	
Hori	184.318	QP	37.6	16.2	9.0	32.2	30.6	43.5	12.9	
Hori	307.197	QP	40.4	14.8	10.0	32.1	33.1	46.0	12.9	
Hori	417.788	QP	34.2	17.5	10.8	32.0	30.5	46.0	15.5	
Hori	761.849	QP	32.1	21.3	12.9	31.7	34.6	46.0	11.4	
Hori	958.455	QP	27.8	22.8	13.8	30.7	33.7	46.0	12.3	
Hori	4882.000	PK	44.0	31.9	4.0	31.4	48.5	73.9	25.4	
Hori	7323.000	PK	41.2	36.5	4.7	32.5	49.9	73.9	24.0	
Hori	9764.000	PK	42.0	38.3	5.4	33.0	52.7	73.9	21.2	
Hori	4882.000	AV	34.6	31.9	4.0	31.4	39.1	53.9	14.8	
Hori	7323.000	AV	31.9	36.5	4.7	32.5	40.6	53.9	13.3	
Hori	9764.000	AV	32.0	38.3	5.4	33.0	42.7	53.9	11.2	
Vert	73.727	QP	41.8	6.5	7.8	32.1	24.0	40.0	16.0	
Vert	98.303	QP	41.6	9.8	8.1	32.3	27.2	43.5	16.3	
Vert	183.999	QP	35.3	16.2	9.0	32.2	28.3	43.5	15.2	
Vert	737.273	QP	29.7	20.9	12.7	31.8	31.5	46.0	14.5	
Vert	761.849	QP	30.9	21.3	12.9	31.7	33.4	46.0	12.6	
Vert	958.455	QP	26.2	22.8	13.8	30.7	32.1	46.0	13.9	
Vert	4882.000	PK	45.7	31.9	4.0	31.4	50.2	73.9	23.7	
Vert	7323.000	PK	41.5	36.5	4.7	32.5	50.2	73.9	23.7	
Vert	9764.000	PK	41.6	38.3	5.4	33.0	52.3	73.9	21.6	
Vert	4882.000	AV	36.0	31.9	4.0	31.4	40.5	53.9	13.4	
Vert	7323.000	AV	32.1	36.5	4.7	32.5	40.8	53.9	13.1	
Vert	9764.000	AV	32.1	38.3	5.4	33.0	42.8	53.9	11.1	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 10GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Distance factor: 10GHz-26.5GHz 20log(3.0m/1.0m)= 9.5dB

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Radiated Spurious Emission

Test place Head Office EMC Lab. No.3 Semi Anechoic Chamber
Report No. 4786001507H
Date 01/29/2013 01/29/2013
Temperature/ Humidity 22 deg. C / 30% RH 22 deg. C / 30% RH
Engineer Hiroshi Kukita Katsunori Okai
(1-10GHz) (Below 1GHz and Above 10GHz)
Mode Tx, 3DH5 2480MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	73.727	QP	43.9	6.5	7.8	32.1	26.1	40.0	13.9	
Hori	184.318	QP	37.5	16.2	9.0	32.2	30.5	43.5	13.0	
Hori	307.199	QP	40.5	14.8	10.0	32.1	33.2	46.0	12.8	
Hori	417.788	QP	34.3	17.5	10.8	32.0	30.6	46.0	15.4	
Hori	761.849	QP	32.6	21.3	12.9	31.7	35.1	46.0	10.9	
Hori	958.456	QP	27.9	22.8	13.8	30.7	33.8	46.0	12.2	
Hori	2483.500	PK	45.0	27.7	2.3	32.3	42.7	73.9	31.2	
Hori	4960.000	PK	45.3	32.2	4.0	31.4	50.1	73.9	23.8	
Hori	7440.000	PK	42.1	36.7	4.7	32.6	50.9	73.9	23.0	
Hori	9920.000	PK	42.3	38.6	5.4	33.1	53.2	73.9	20.7	
Hori	2483.500	AV	34.0	27.7	2.3	32.3	31.7	53.9	22.2	
Hori	4960.000	AV	37.7	32.2	4.0	31.4	42.5	53.9	11.4	
Hori	7440.000	AV	30.3	36.7	4.7	32.6	39.1	53.9	14.8	
Hori	9920.000	AV	30.8	38.6	5.4	33.1	41.7	53.9	12.2	
Vert	73.727	QP	43.5	6.5	7.8	32.1	25.7	40.0	14.3	
Vert	98.303	QP	41.1	9.8	8.1	32.3	26.7	43.5	16.8	
Vert	183.999	QP	35.1	16.2	9.0	32.2	28.1	43.5	15.4	
Vert	737.273	QP	29.1	20.9	12.7	31.8	30.9	46.0	15.1	
Vert	761.849	QP	30.7	21.3	12.9	31.7	33.2	46.0	12.8	
Vert	958.456	QP	26.1	22.8	13.8	30.7	32.0	46.0	14.0	
Vert	2483.500	PK	45.0	27.7	2.3	32.3	42.7	73.9	31.2	
Vert	4960.000	PK	44.9	32.2	4.0	31.4	49.7	73.9	24.2	
Vert	7440.000	PK	42.2	36.7	4.7	32.6	51.0	73.9	22.9	
Vert	9920.000	PK	42.0	38.6	5.4	33.1	52.9	73.9	21.0	
Vert	2483.500	AV	33.4	27.7	2.3	32.3	31.1	53.9	22.8	
Vert	4960.000	AV	38.2	32.2	4.0	31.4	43.0	53.9	10.9	
Vert	7440.000	AV	30.2	36.7	4.7	32.6	39.0	53.9	14.9	
Vert	9920.000	AV	30.9	38.6	5.4	33.1	41.8	53.9	12.1	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 10GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Distance factor: 10GHz-26.5GHz $20\log(3.0\text{m}/1.0\text{m})= 9.5\text{dB}$

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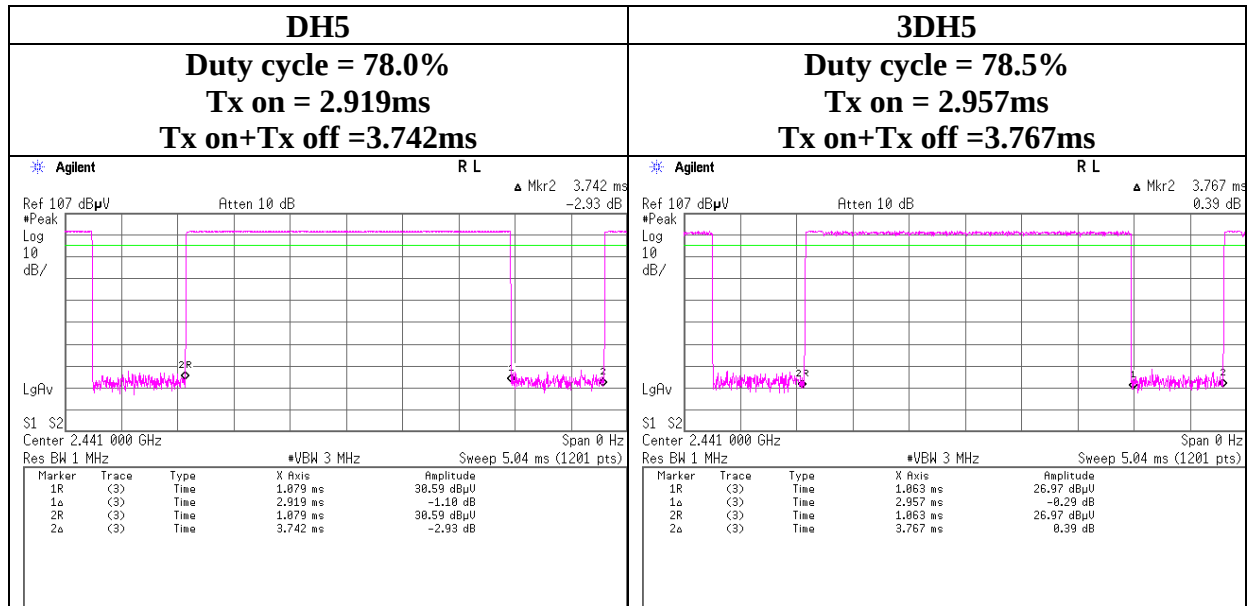
Head Office EMC Lab.

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Duty Cycle confirmation



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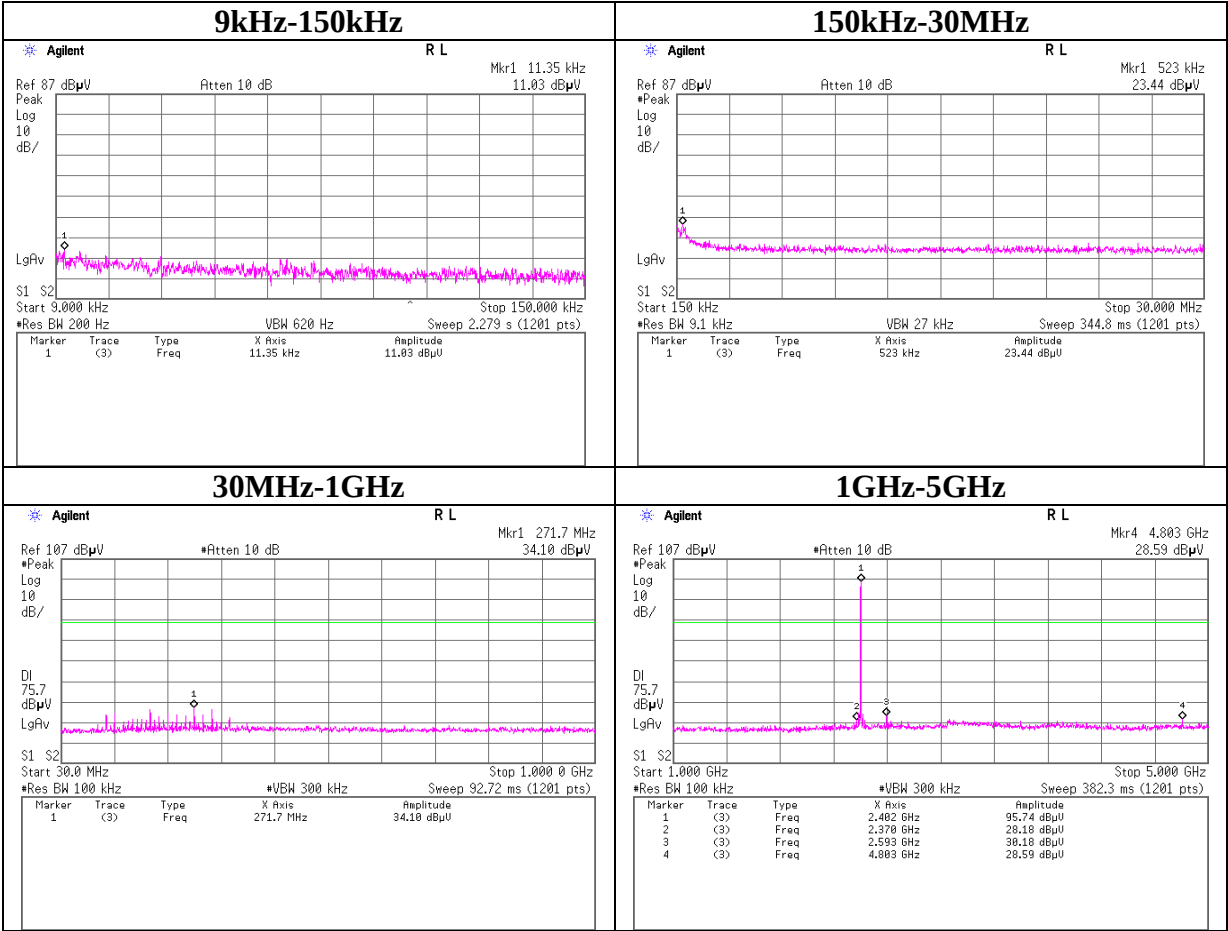
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

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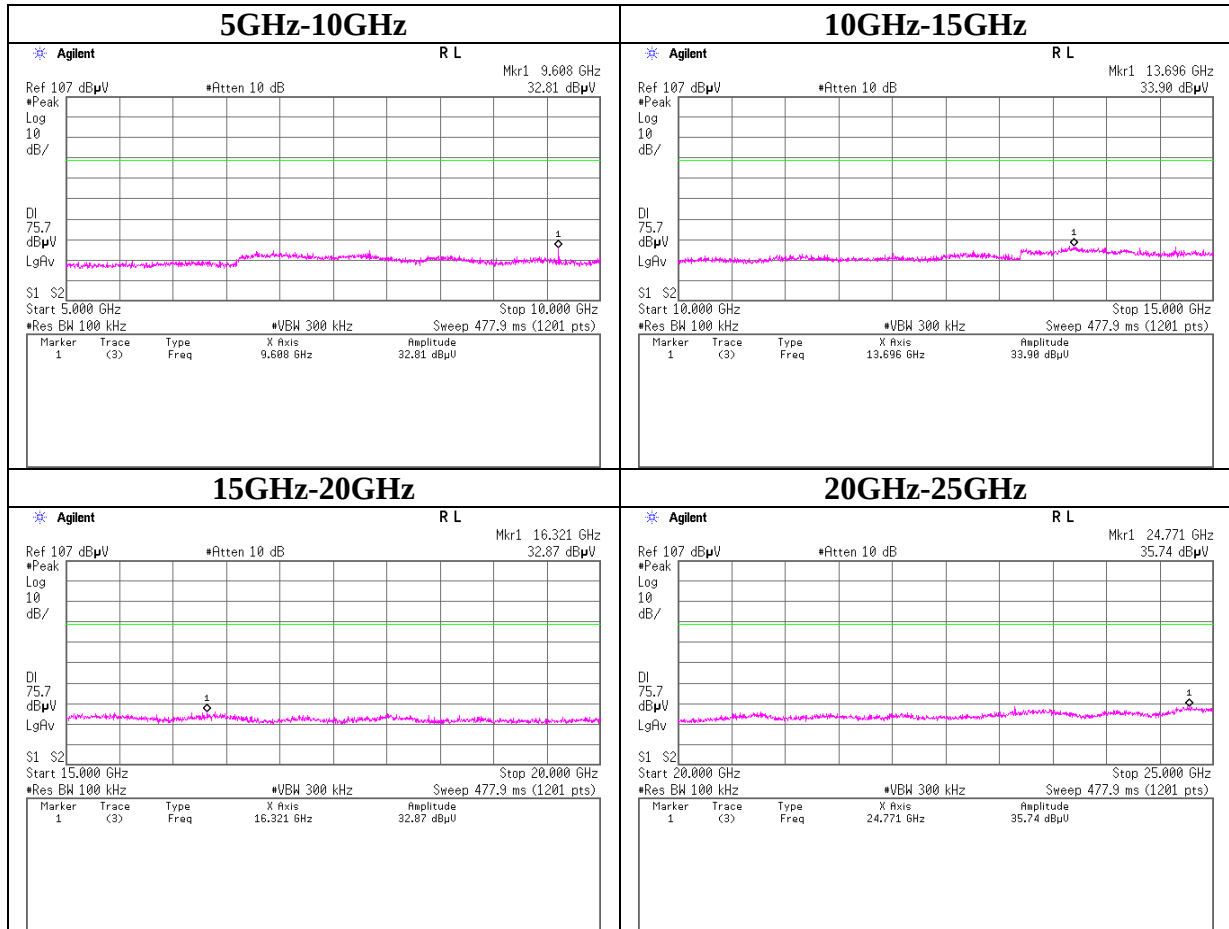
Conducted Spurious Emission

Tx DH5 2402MHz



Conducted Spurious Emission

Tx DH5 2402MHz



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Head Office EMC Lab.

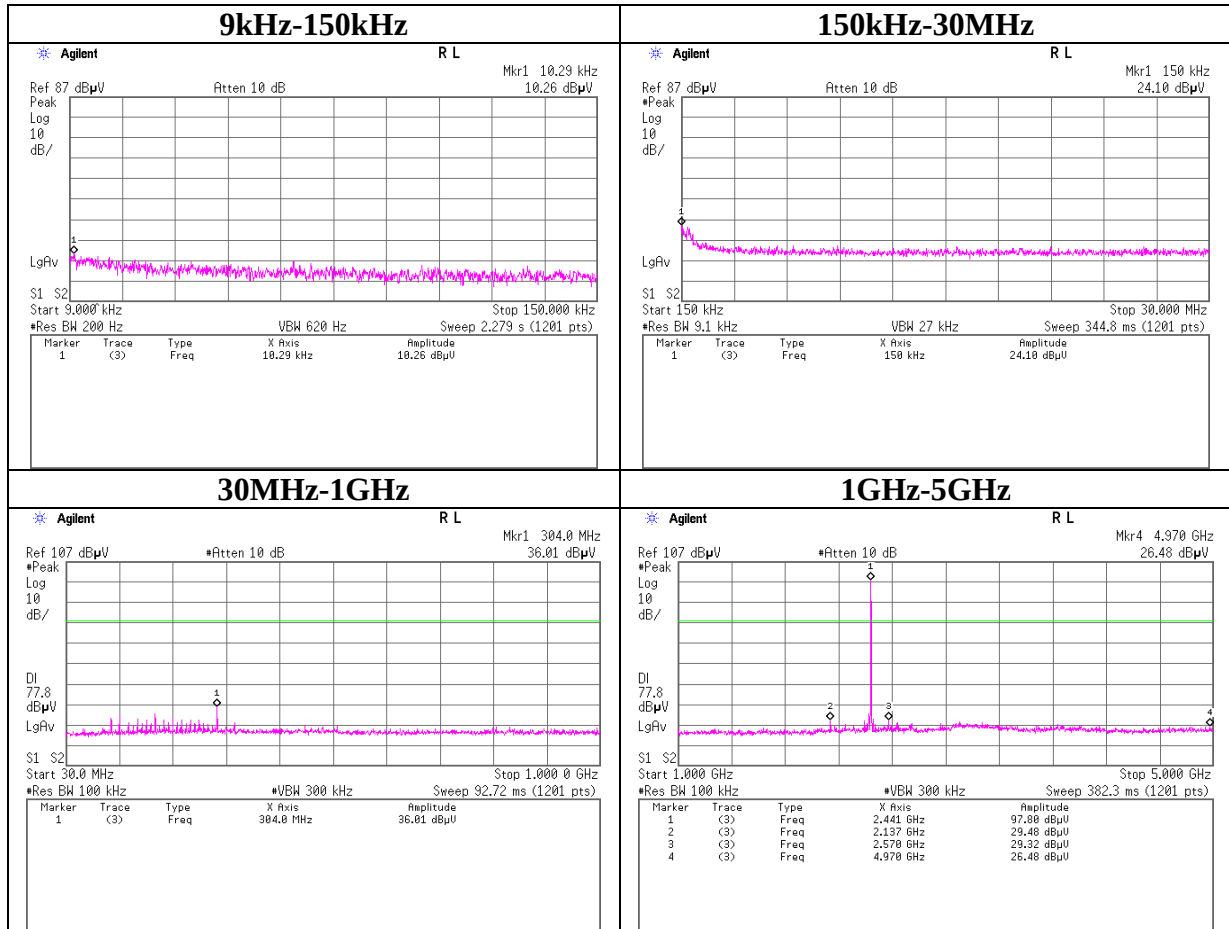
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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Conducted Spurious Emission

Tx DH5 2441MHz



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Head Office EMC Lab.

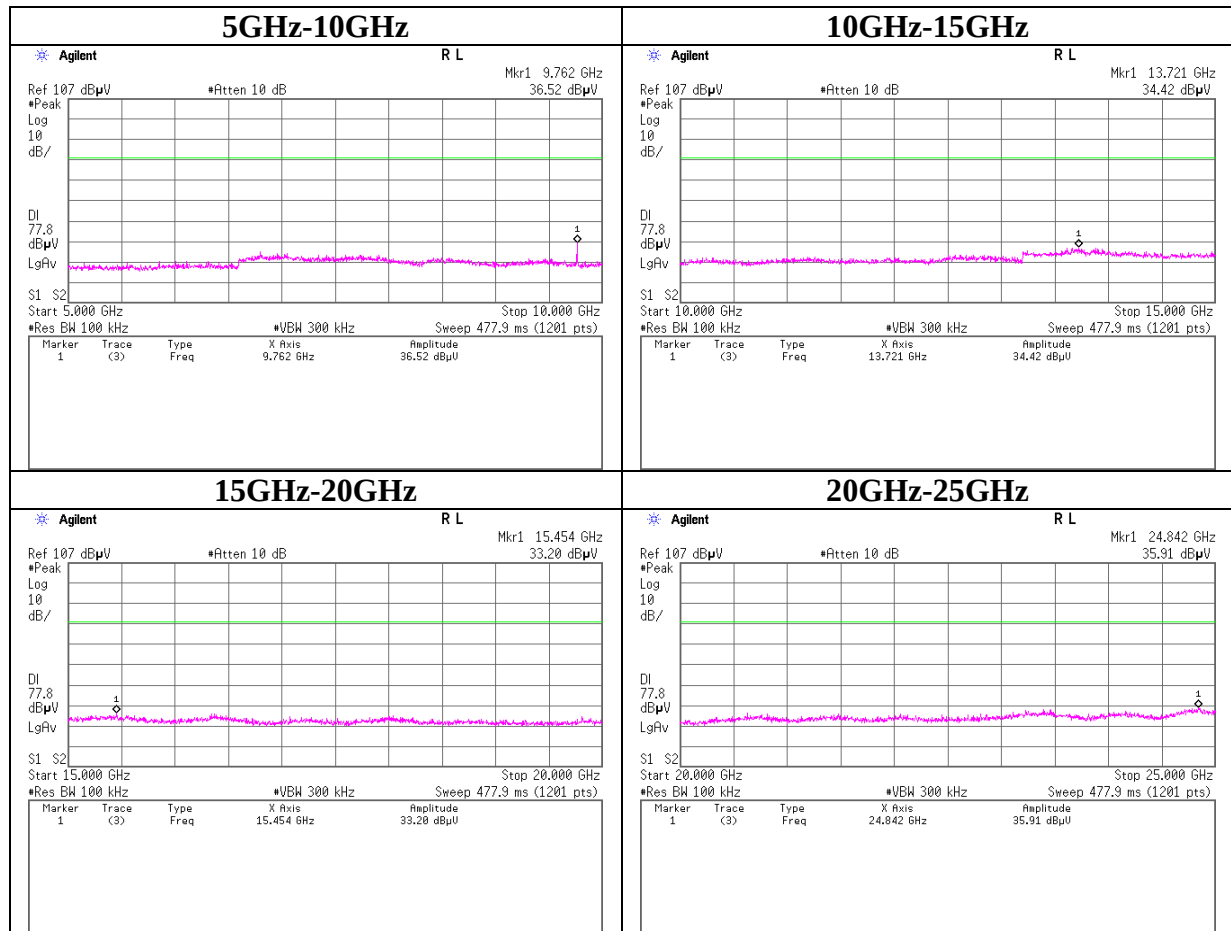
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Conducted Spurious Emission

Tx DH5 2441MHz



UL Japan, Inc.

Head Office EMC Lab.

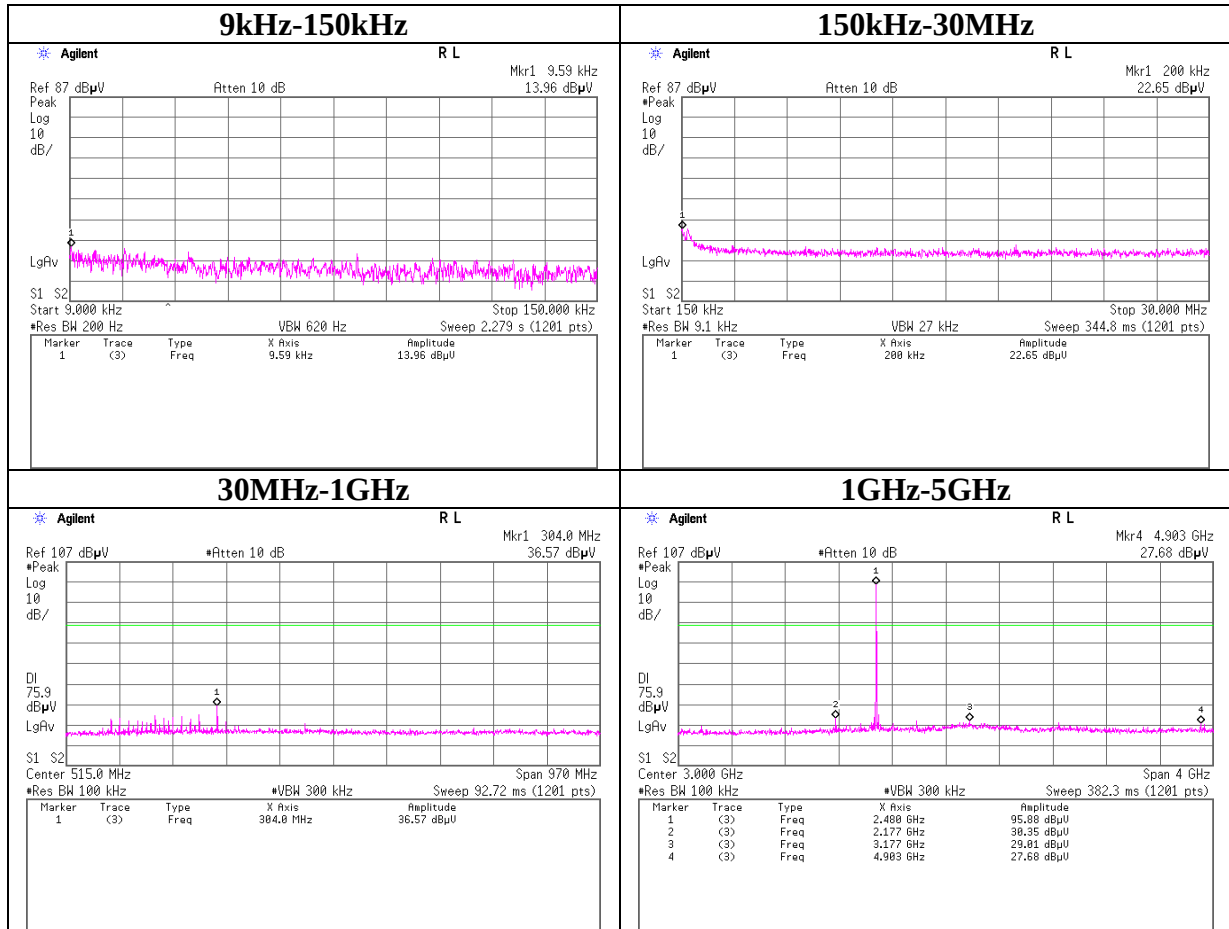
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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Conducted Spurious Emission

Tx DH5 2480MHz



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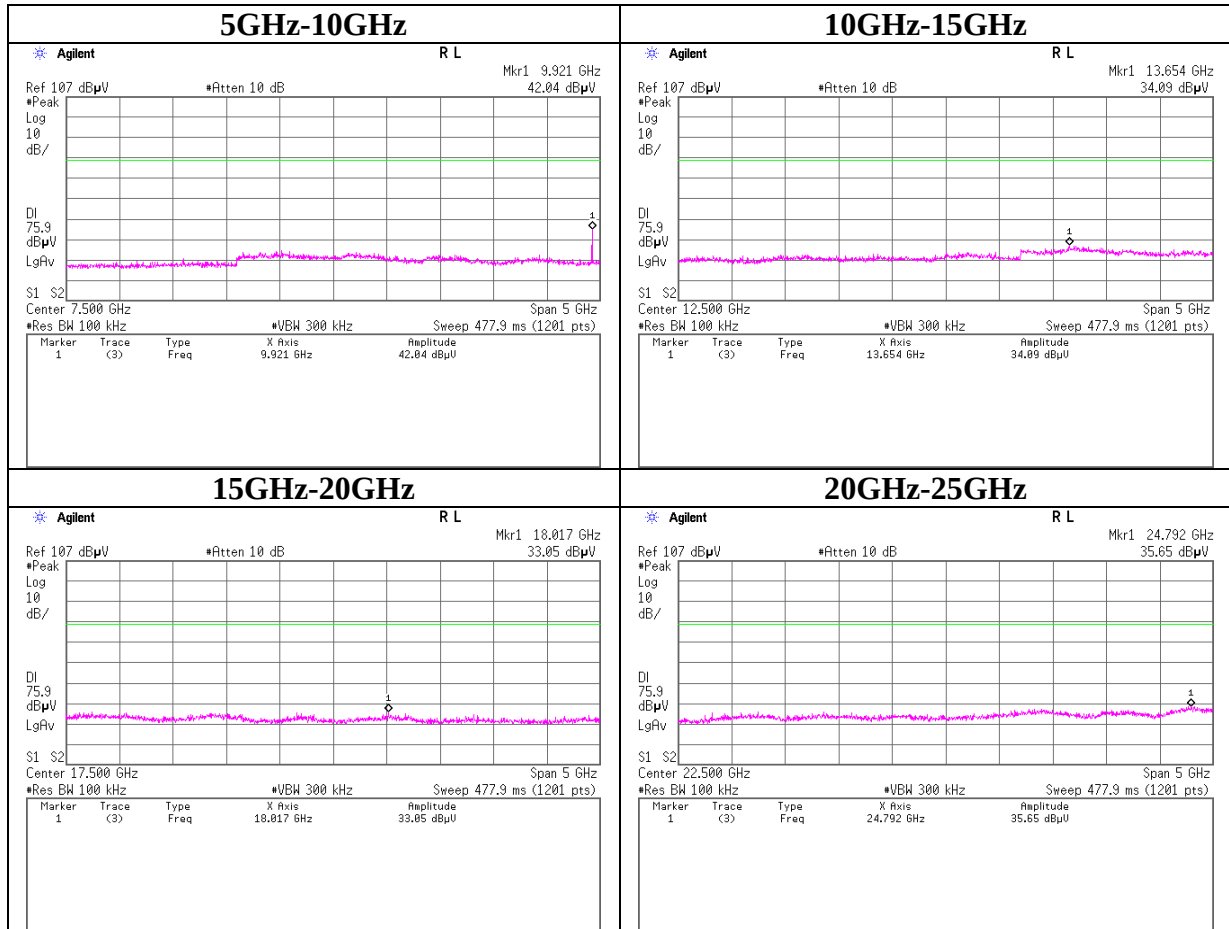
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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Conducted Spurious Emission

Tx DH5 2480MHz



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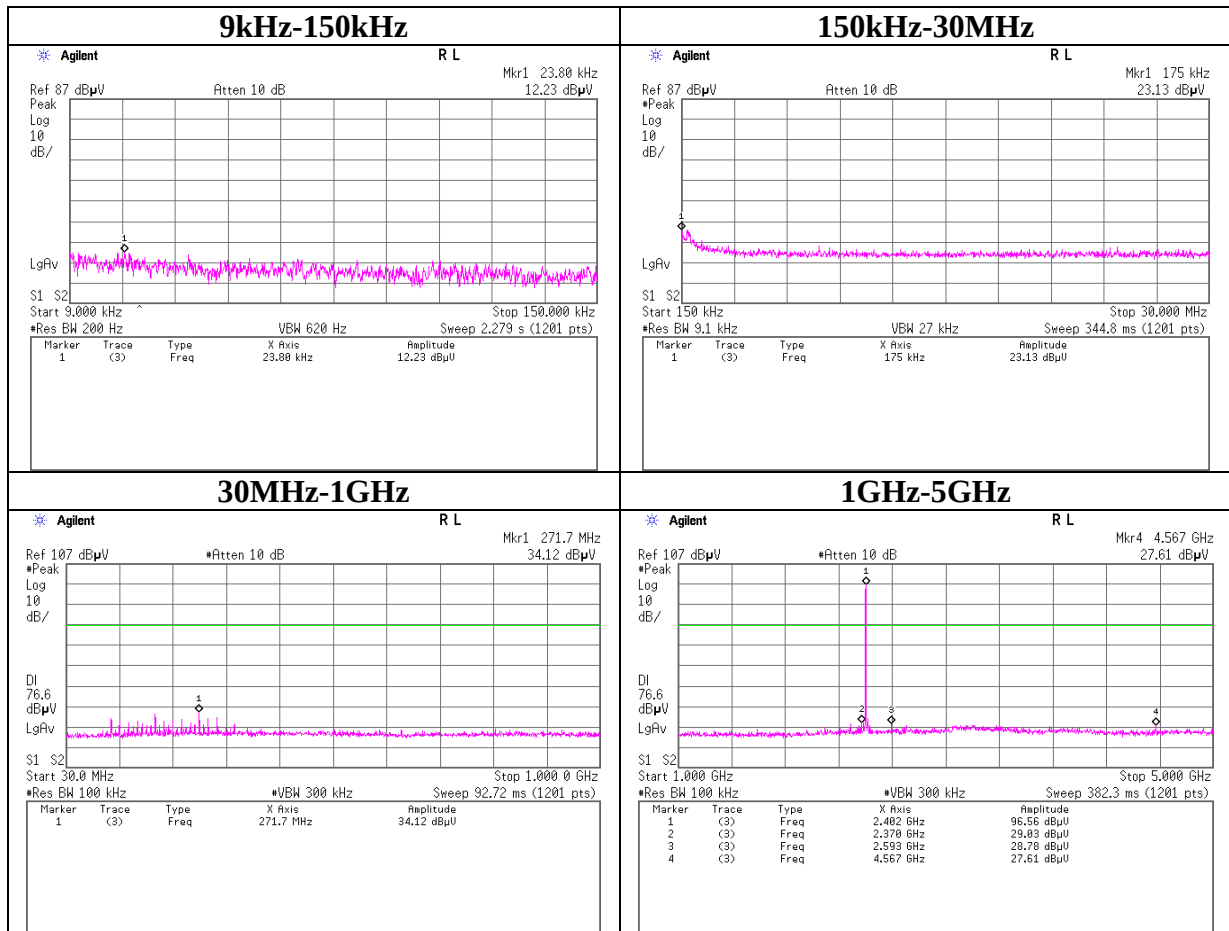
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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Conducted Spurious Emission

Tx 3DH5 2402MHz



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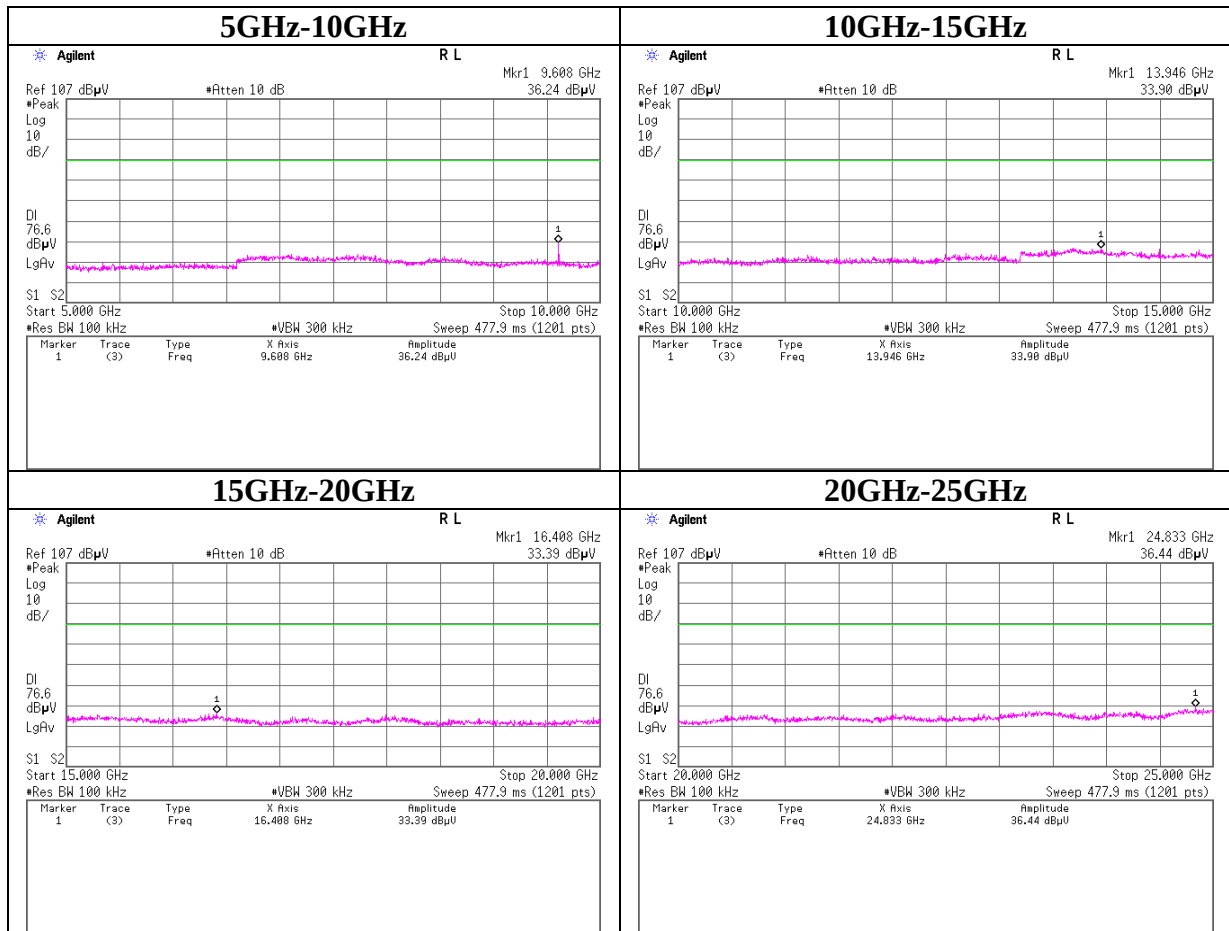
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Conducted Spurious Emission

Tx 3DH5 2402MHz



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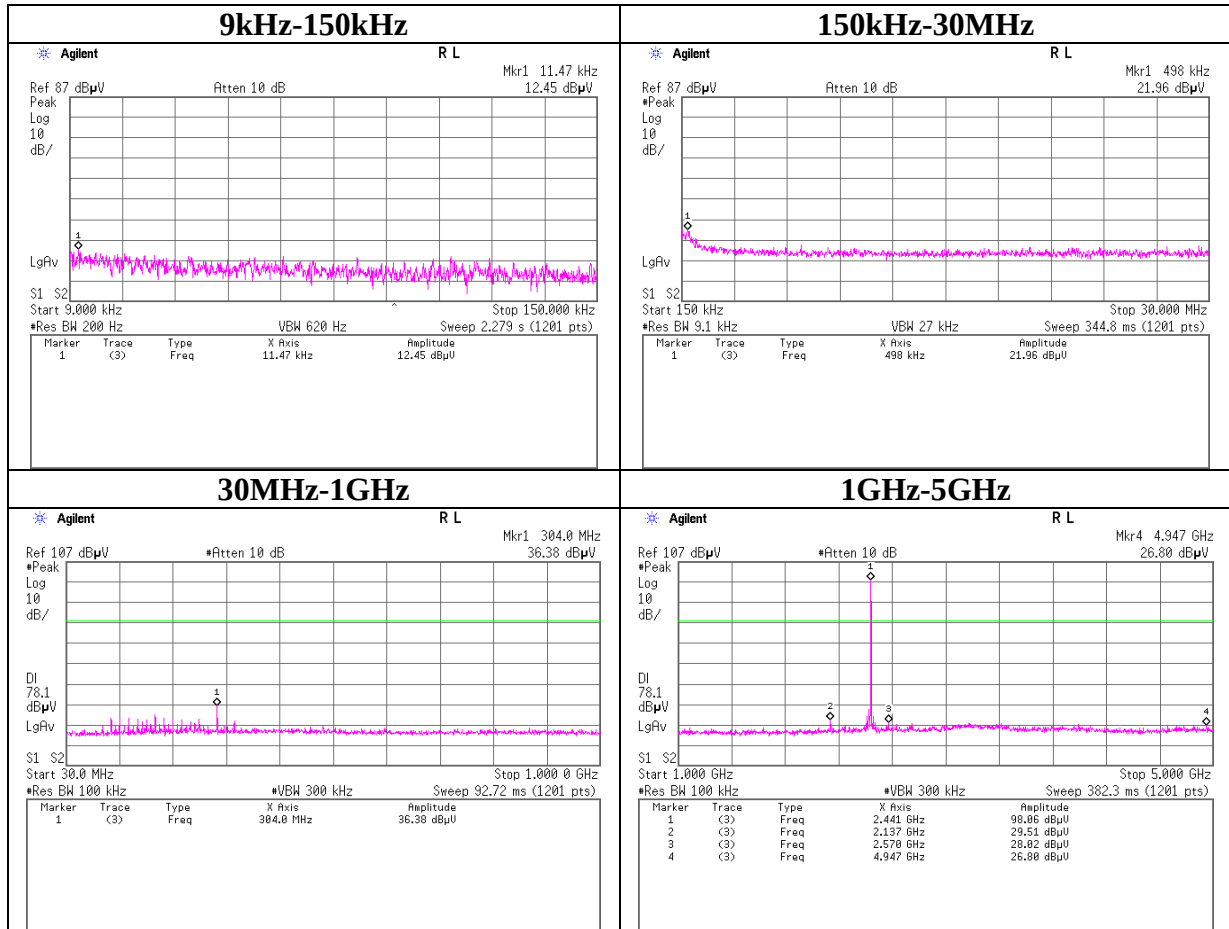
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Conducted Spurious Emission

Tx 3DH5 2441MHz



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Head Office EMC Lab.

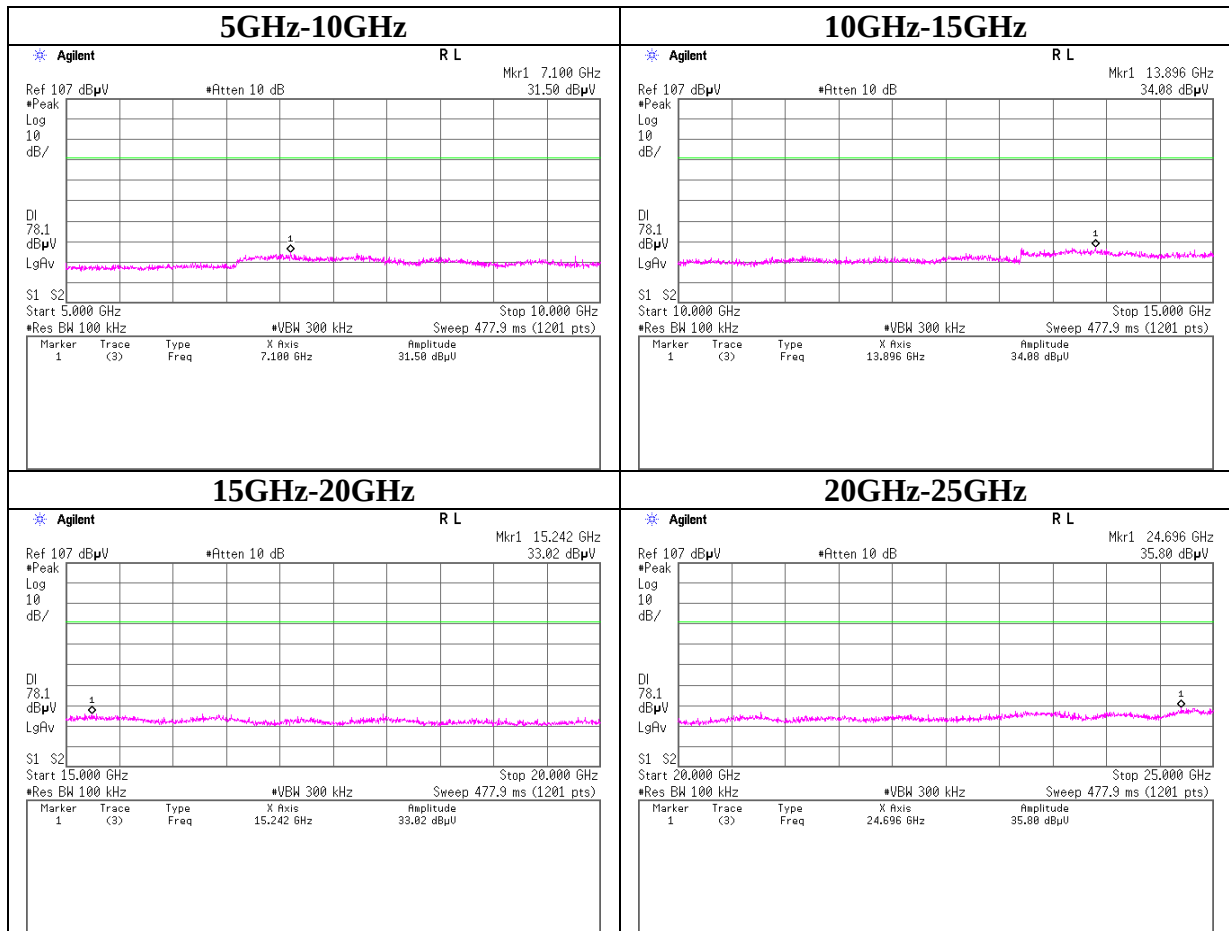
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Conducted Spurious Emission

Tx 3DH5 2441MHz



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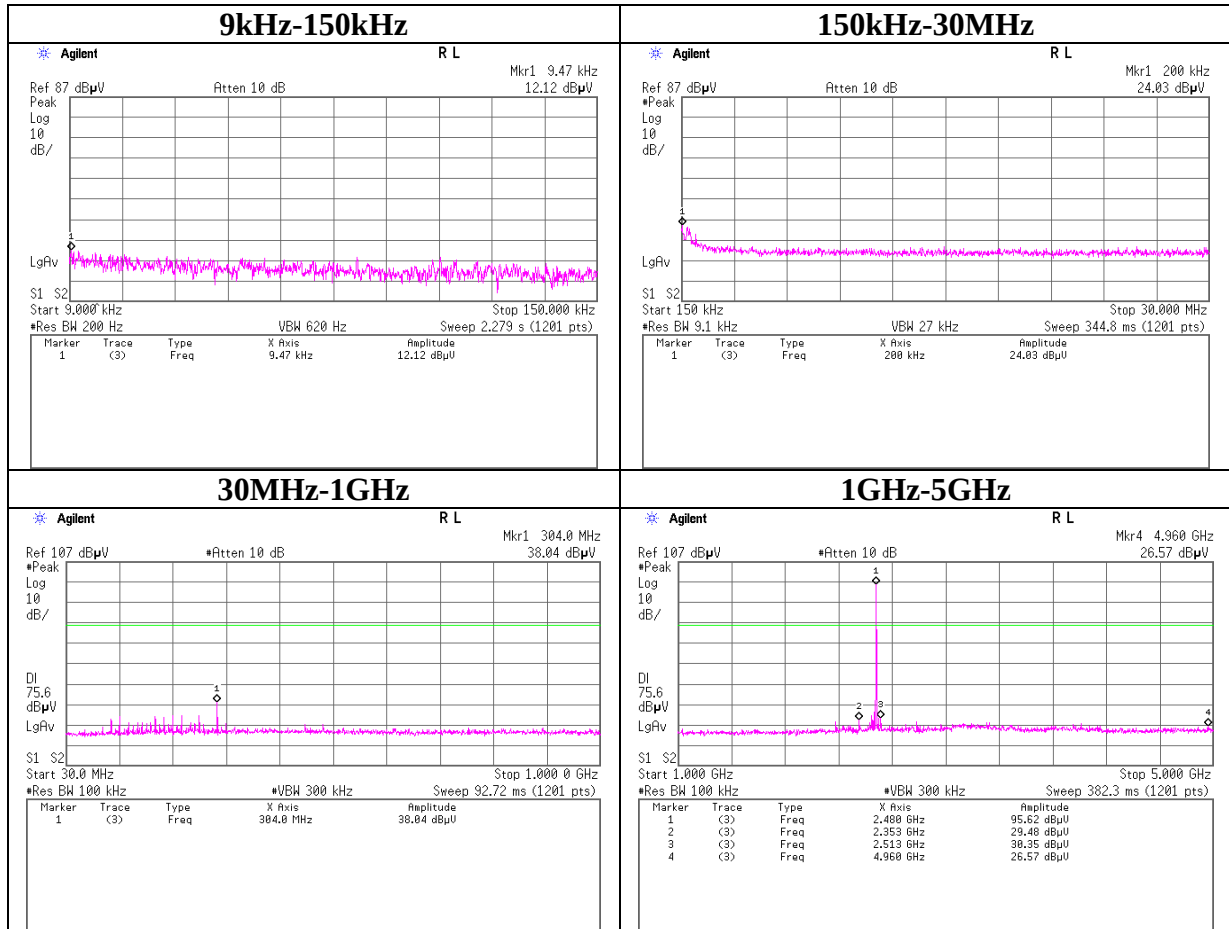
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Conducted Spurious Emission

Tx 3DH5 2480MHz



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Head Office EMC Lab.

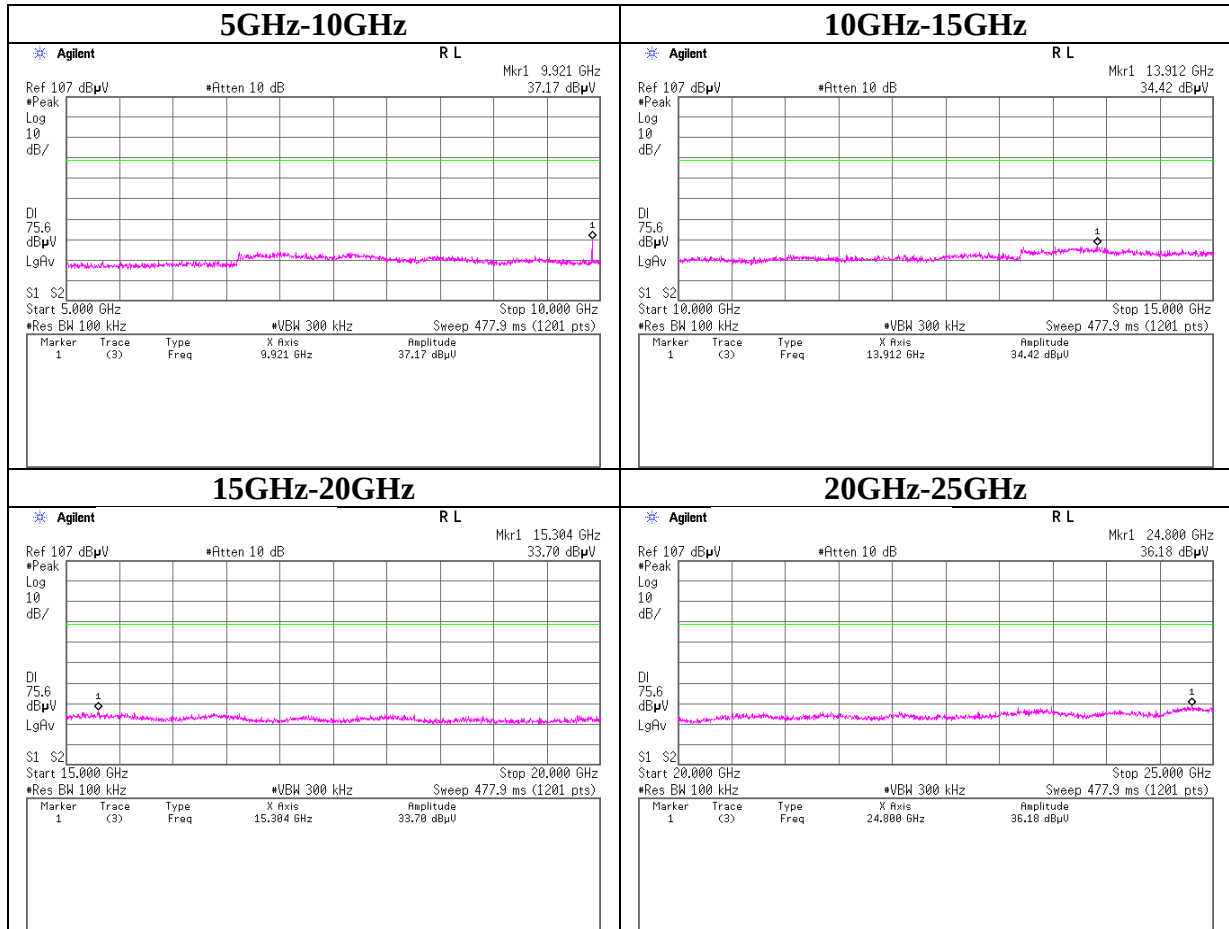
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Conducted Spurious Emission

Tx 3DH5 2480MHz



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Head Office EMC Lab.

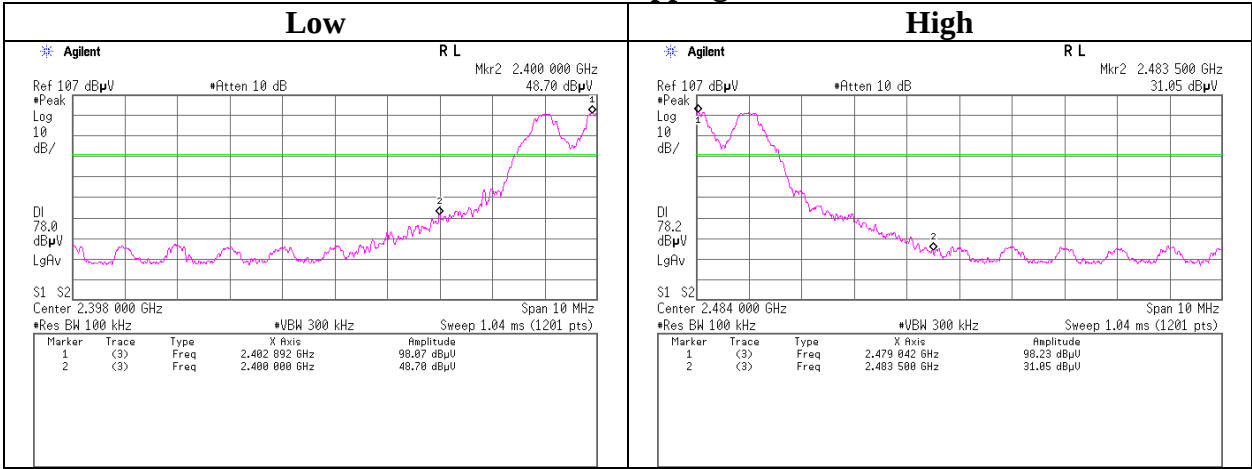
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

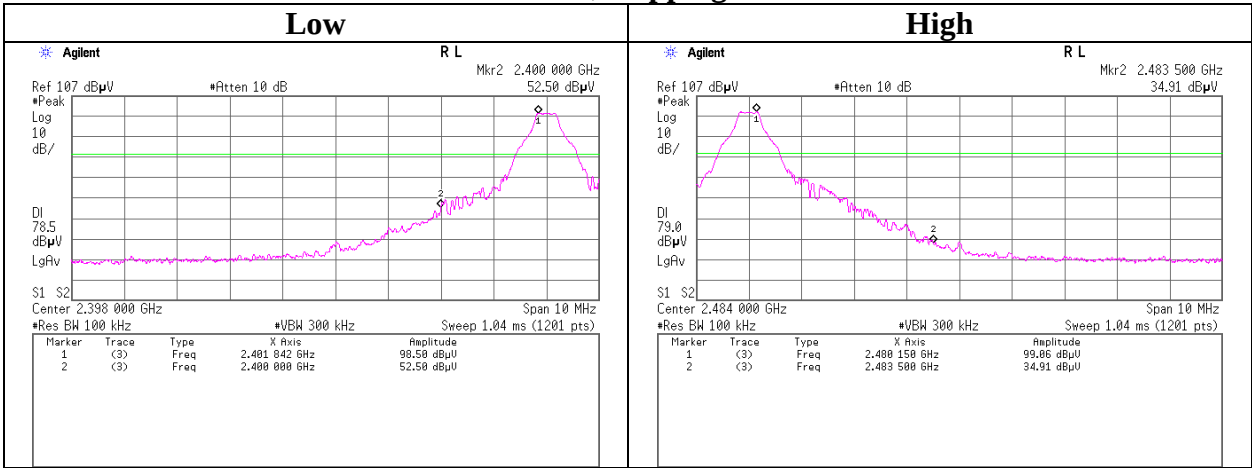
Facsimile : +81 596 24 8124

Conducted Emission Band Edge compliance

Tx DH5, Hopping on

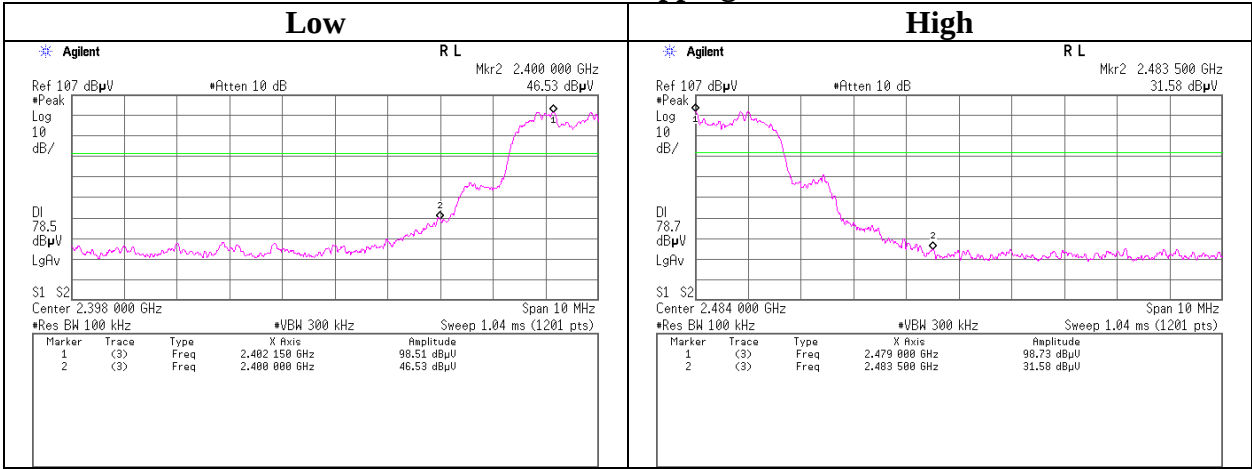


Tx DH5, Hopping off

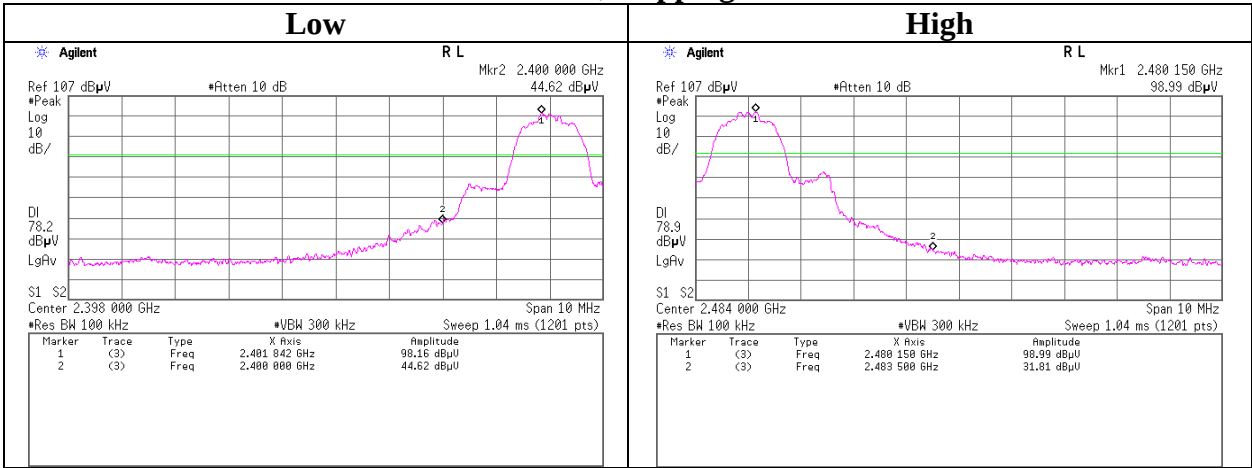


Conducted Emission Band Edge compliance

Tx 3DH5, Hopping on



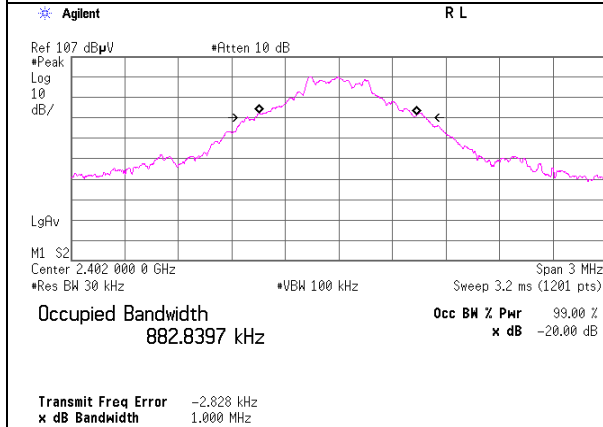
Tx 3DH5, Hopping off



99%Occupied Bandwidth

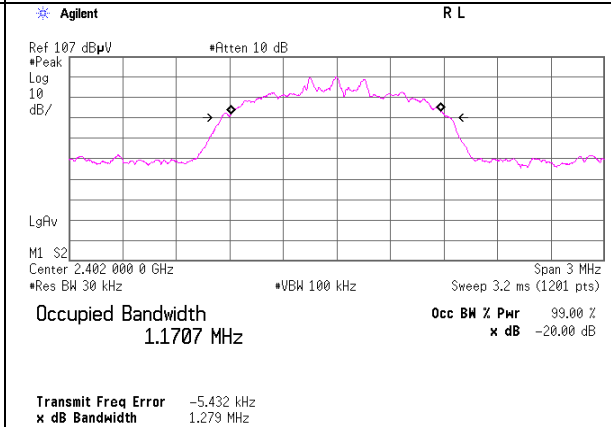
Tx DH5, Hopping off

2402MHz

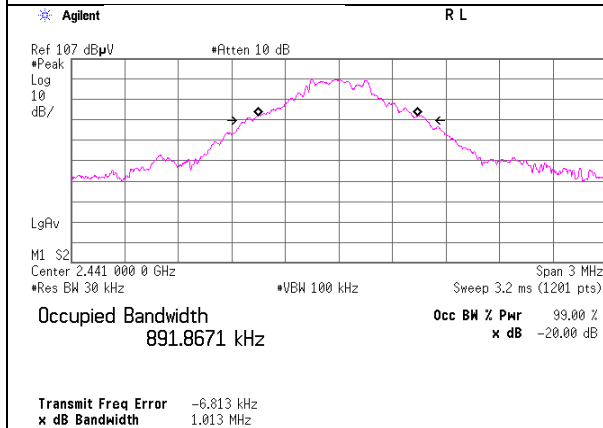


Tx 3DH5, Hopping off

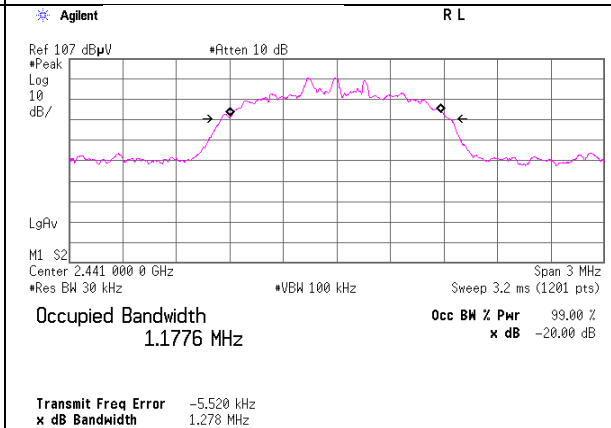
2402MHz



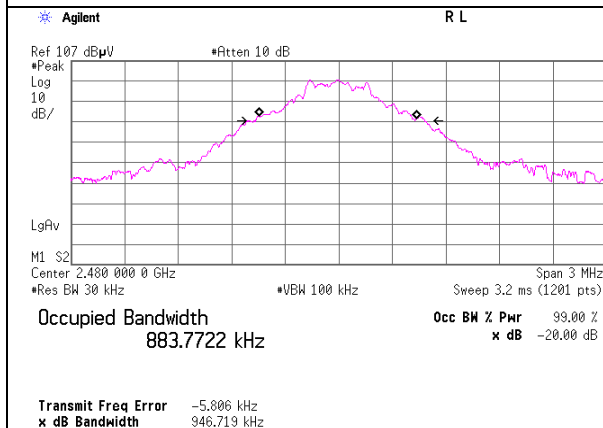
2441MHz



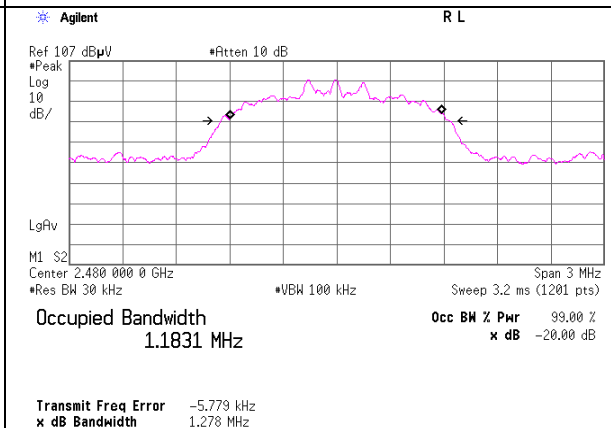
2441MHz



2480MHz



2480MHz



UL Japan, Inc.

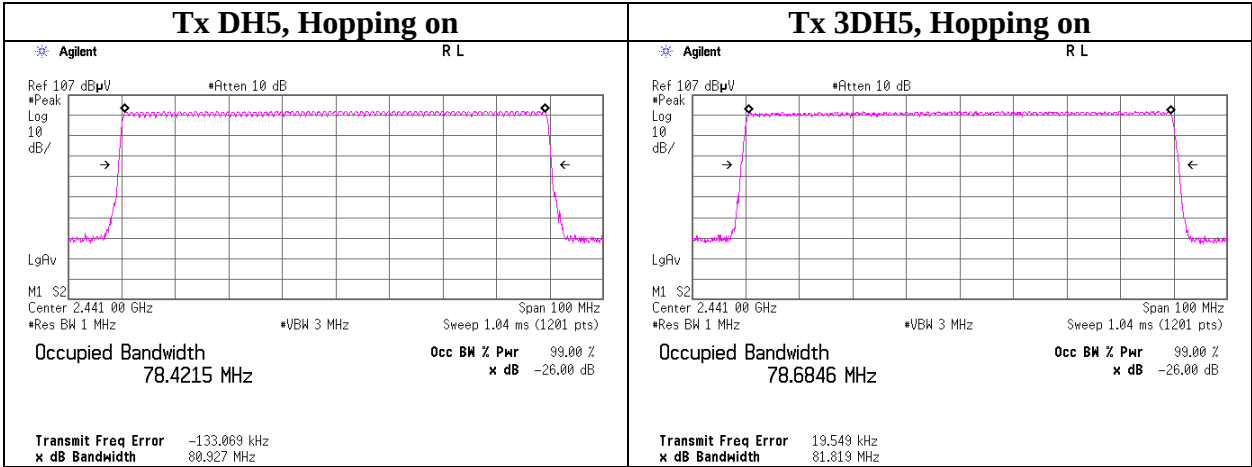
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99% Occupied Bandwidth



APPENDIX 2: Test instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-03	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2012/02/24 * 12
MOS-13	Thermo-Hygrometer	Custom	CTH-180	-	RE	2012/02/06 * 12
MJM-16	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE/CE	-
MSA-03	Spectrum Analyzer	Agilent	E4448A	MY44020357	RE	2012/11/20 * 12
MHA-20	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	258	RE	2012/05/25 * 12
MCC-133	Microwave Cable	HUBER+SUHNER	SUCOFLEX104	336164/4(1m) / 340640(5m)	RE	2012/09/05 * 12
MPA-11	MicroWave System Amplifier	Agilent	83017A	MY39500779	RE	2012/03/29 * 12
MHA-16	Horn Antenna 15-40GHz	Schwarzbeck	BBHA9170	BBHA9170306	RE	2012/05/21 * 12
MHF-06	High Pass Filter 3.5-24GHz	TOKIMEC	TF323DCA	601	RE	2012/05/30 * 12
MSA-10	Spectrum Analyzer	Agilent	E4448A	MY46180655	AT/CE	2012/02/03 * 12
MPM-09	Power Meter	Anritsu	ML2495A	6K00003348	AT	2012/10/08 * 12
MPSE-12	Power sensor	Anritsu	MA2411B	011598	AT	2012/10/08 * 12
MAT-22	Attenuator(10dB) 1-18GHz	Orient Microwave	BX10-0476-00	-	AT	2012/03/27 * 12
MCC-67	Microwave Cable 1G-40GHz	Suhner	SUCOFLEX102	28635/2	AT	2012/04/25 * 12
MTR-08	Test Receiver	Rohde & Schwarz	ESCI	100767	RE	2012/08/23 * 12
MBA-03	Biconical Antenna	Schwarzbeck	BBA9106	1915	RE	2012/10/08 * 12
MLA-03	Logperiodic Antenna	Schwarzbeck	USLP9143	174	RE	2012/10/08 * 12
MCC-51	Coaxial cable	UL Japan	-	-	RE	2012/07/12 * 12
MAT-09	Attenuator(6dB)	Weinschel Corp	2	BK7973	RE	2012/11/06 * 12
MPA-13	Pre Amplifier	SONOMA INSTRUMENT	310	260834	RE	2012/03/16 * 12
MAEC-02	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	CE	2012/06/29 * 12
MOS-22	Thermo-Hygrometer	Custom	CTH-201	0003	CE	2012/02/06 * 12
MJM-14	Measure	KOMELON	KMC-36	-	CE	-
MTR-03	Test Receiver	Rohde & Schwarz	ESCI	100300	CE	2012/04/03 * 12
MLS-07	LISN(AMN)	Schwarzbeck	NSLK8127	8127364	CE(EUT)	2013/01/07 * 12
MCC-13	Coaxial Cable	Fujikura	3D-2W(12m)/ 5D-2W(5m)/ 5D-2W(0.8m)/ 5D-2W(1m)	-	CE	2012/02/16 * 12
MAT-65	Attenuator(13dB)	JFW Industries, Inc.	50FP-013H2 N	-	CE	2013/01/09 * 12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item: CE: Conducted Emission

RE: Radiated Emission

AT: Antenna Terminal Conducted test

UL Japan, Inc.

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